



US008092080B2

(12) **United States Patent**
Mitchell et al.

(10) **Patent No.:** **US 8,092,080 B2**
(45) **Date of Patent:** **Jan. 10, 2012**

(54) **WIRELESS TELEMETRY CIRCUIT
STRUCTURE FOR MEASURING
TEMPERATURE IN HIGH TEMPERATURE
ENVIRONMENTS**

(75) Inventors: **David J. Mitchell**, Oviedo, FL (US);
Anand A. Kulkarni, Oviedo, FL (US);
Ramesh Subramanian, Oviedo, FL
(US); **Edward R. Roesch**, Orlando, FL
(US); **Rod Waits**, Sunnyvale, CA (US);
Roberto Schupbach, Fayetteville, AR
(US); **John R. Fraley**, Fayetteville, AR
(US); **Alexander B. Lostetter**,
Fayetteville, AR (US); **Brice
McPherson**, Fayetteville, AR (US);
Bryon Western, West Fork, AR (US)

(73) Assignee: **Siemens Energy, Inc.**, Orlando, FL (US)

(*) Notice: Subject to any disclaimer, the term of this
patent is extended or adjusted under 35
U.S.C. 154(b) by 817 days.

(21) Appl. No.: **12/192,366**

(22) Filed: **Aug. 15, 2008**

(65) **Prior Publication Data**
US 2010/0039288 A1 Feb. 18, 2010

(51) **Int. Cl.**
G01K 1/00 (2006.01)

(52) **U.S. Cl.** **374/100**

(58) **Field of Classification Search** **374/100**
See application file for complete search history.

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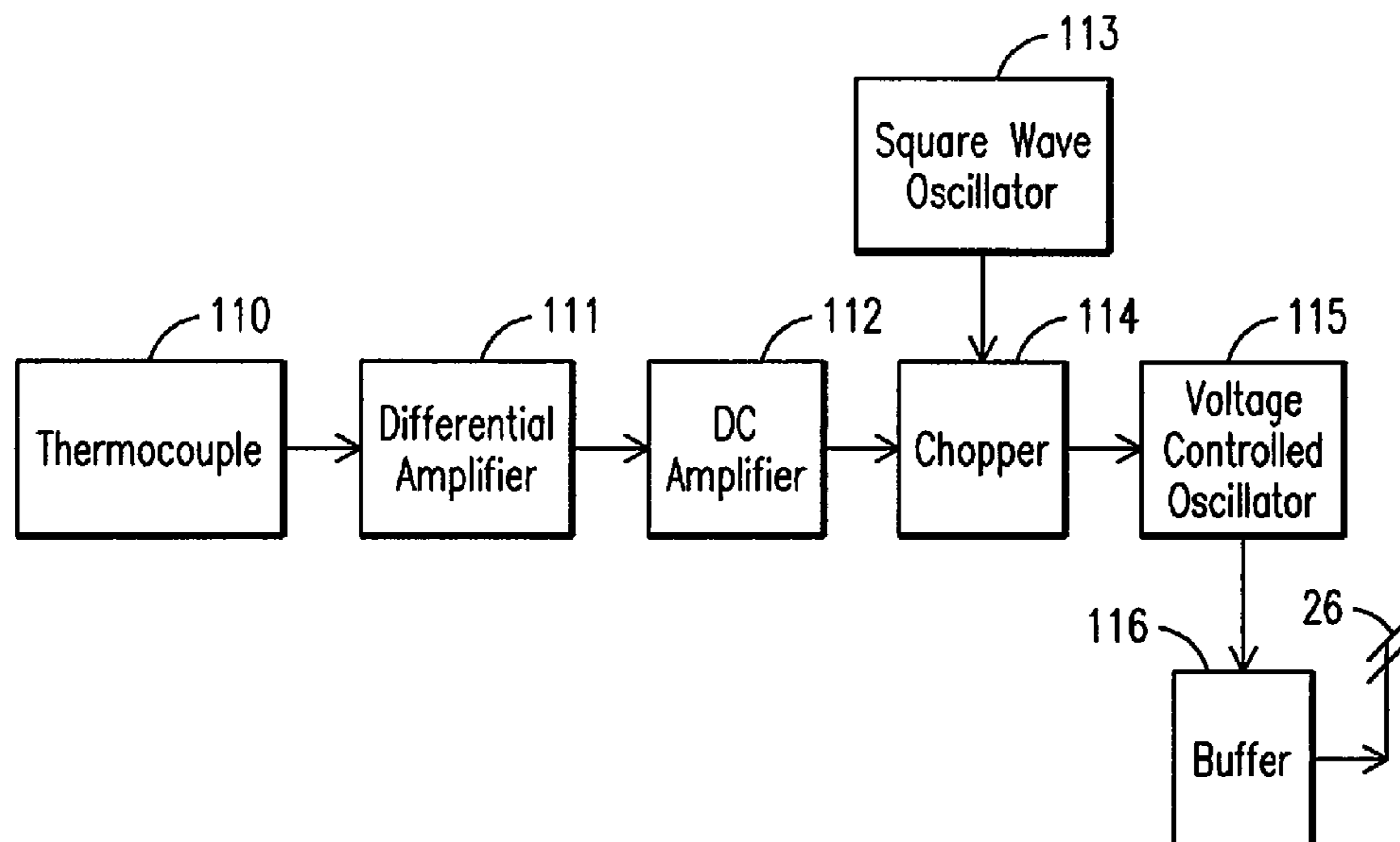
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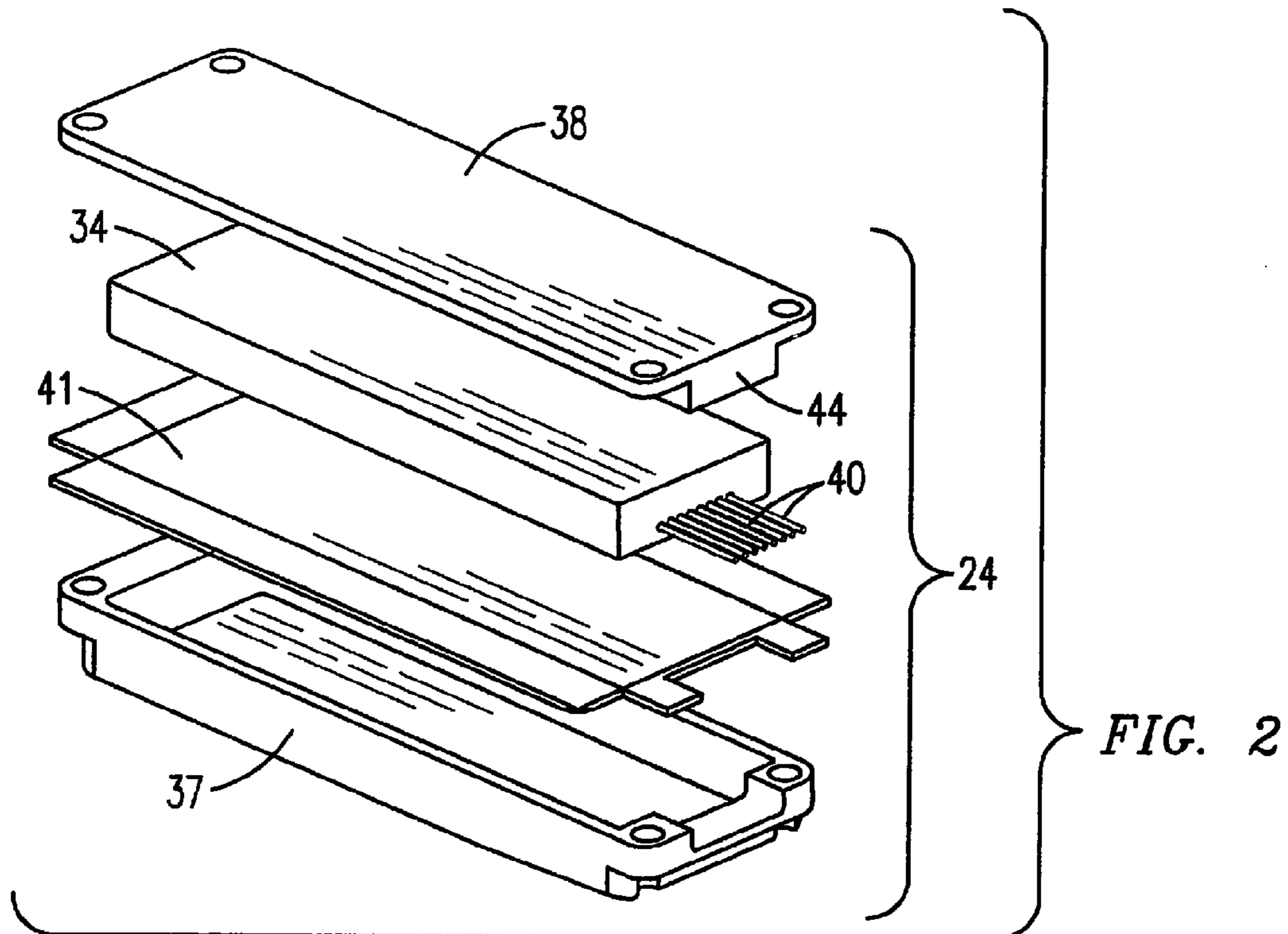
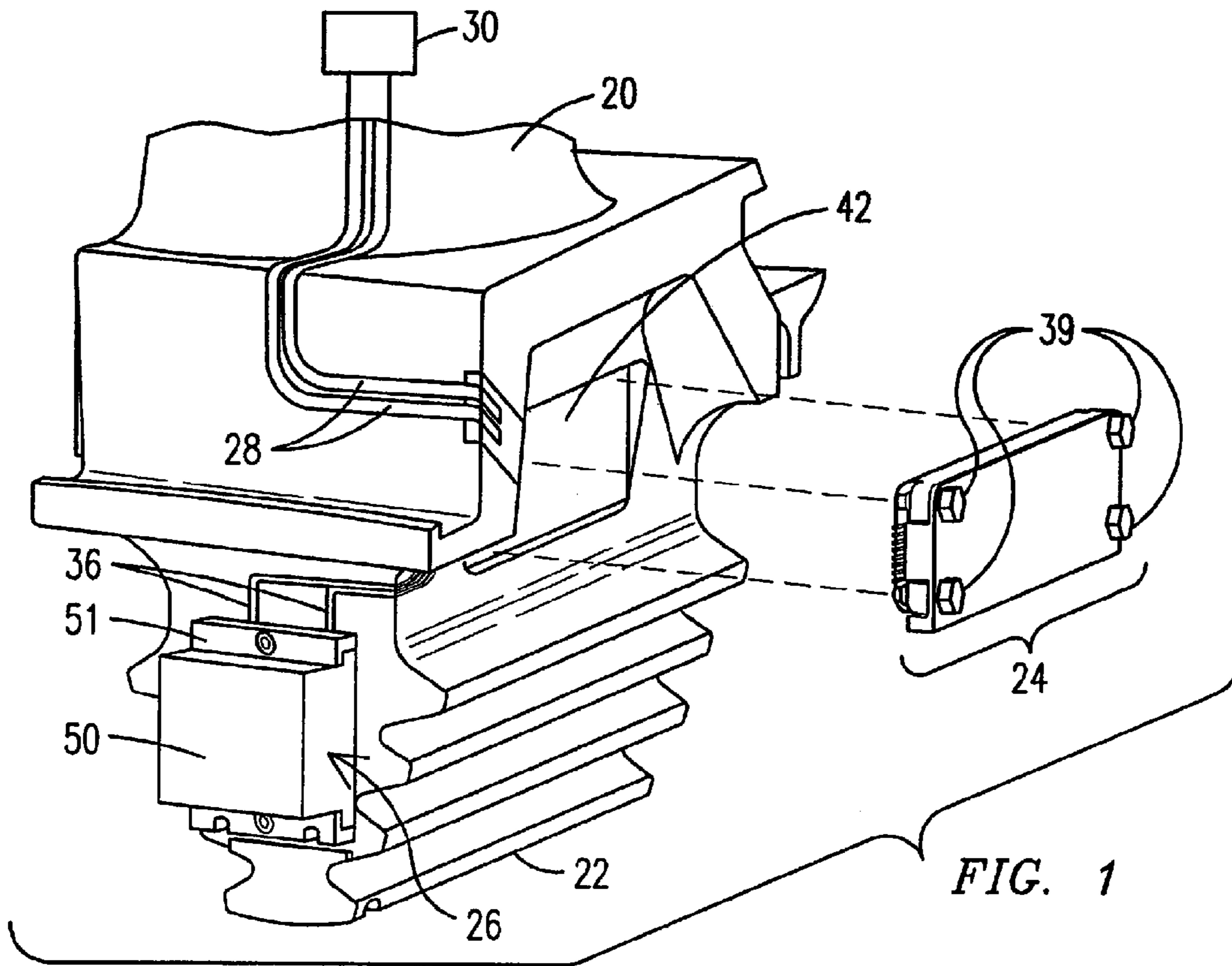
Primary Examiner — Robert L. Deberadinis

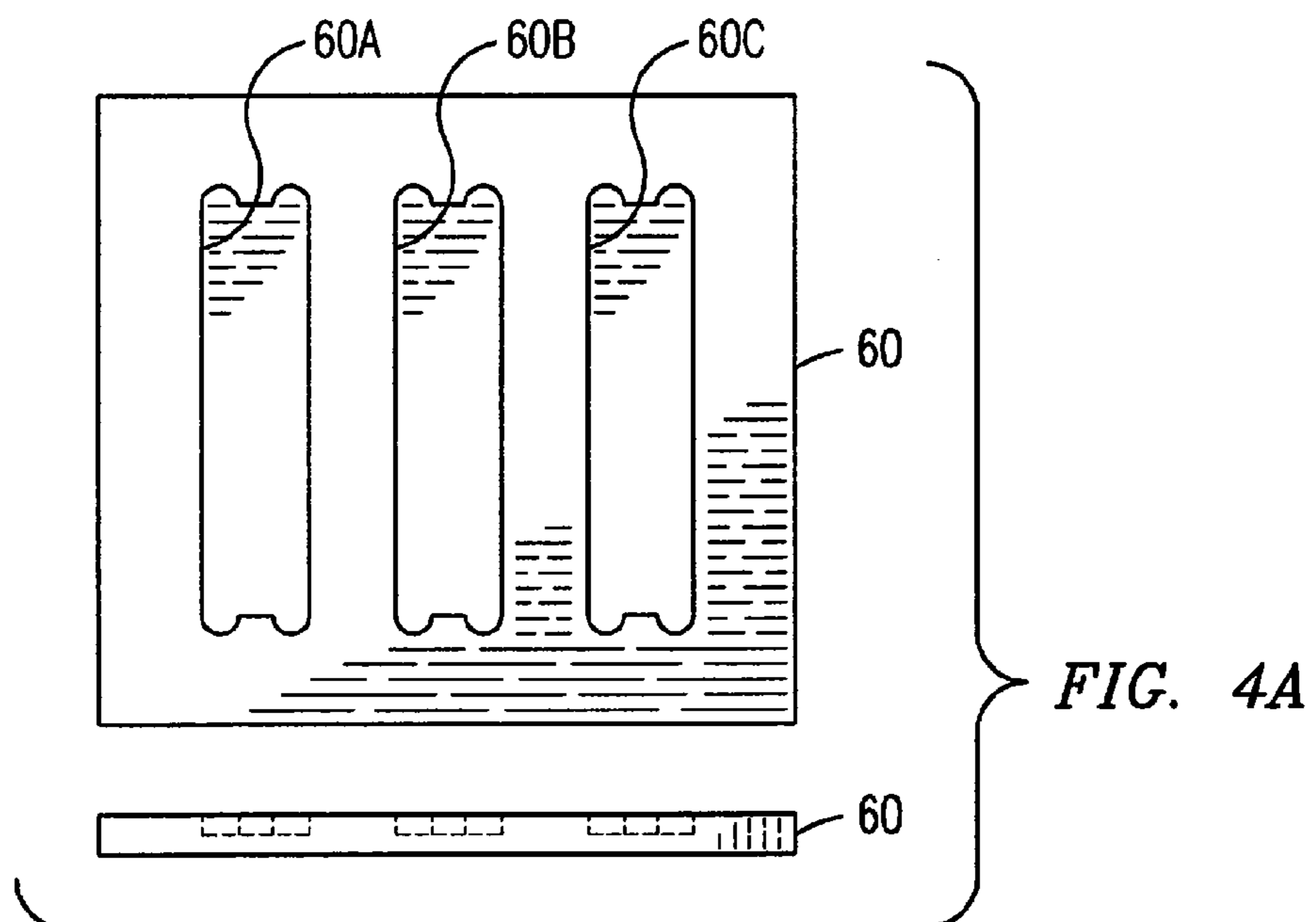
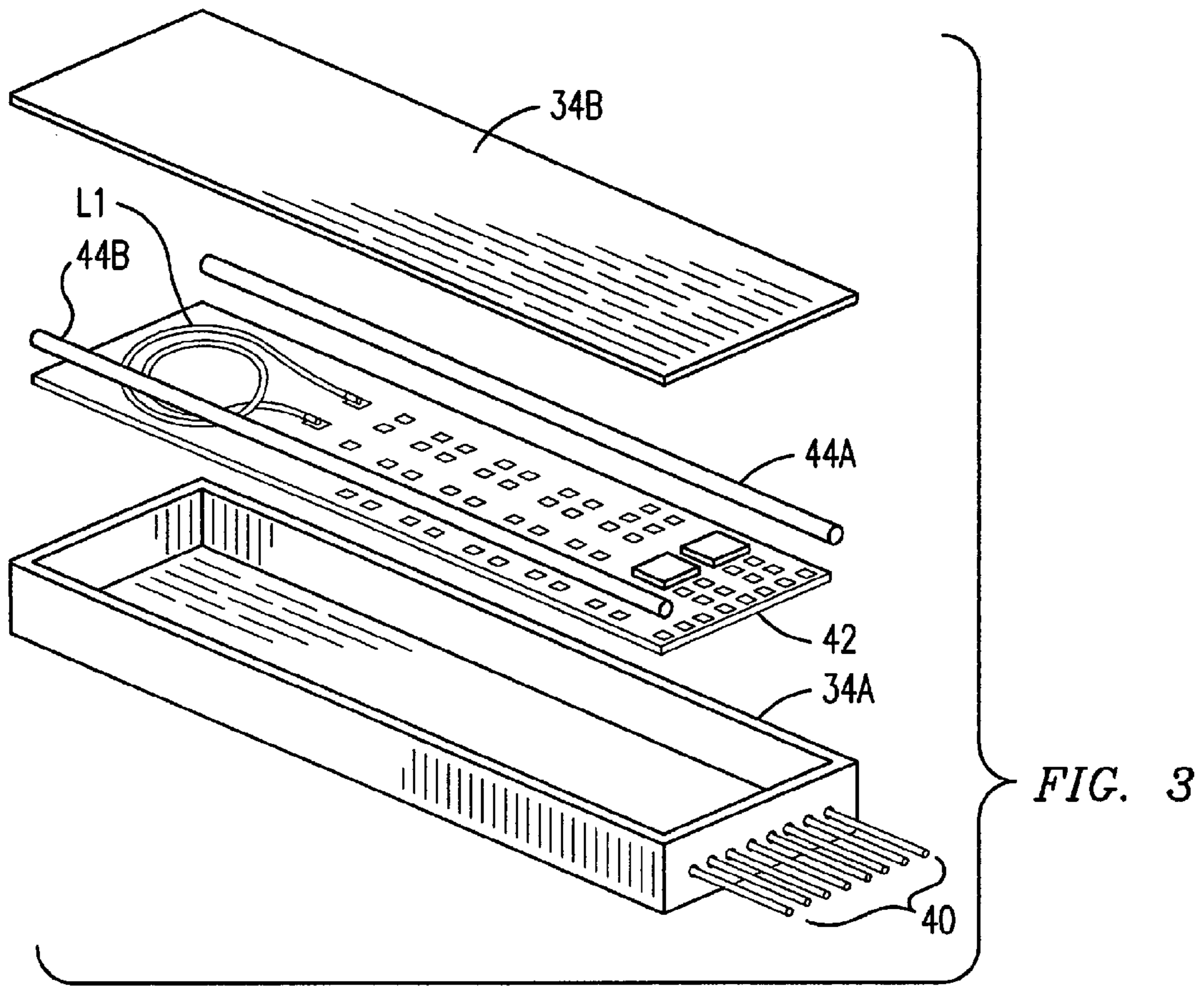
(57) **ABSTRACT**

A circuit affixed to a moving part of an engine for sensing and
processing the temperature of the part. The circuit generates a
signal representative of the temperature sensed by a thermo-
couple (110) and amplified by an amplifier (112). A square
wave oscillator (113) with a temperature sensitive capacitor
(C8) varies its frequency in response to changes of a local
temperature of the circuit. A chopper (114, J27) converts the
output of the amplifier into an alternating current signal. The
chopper is gated by the square wave oscillator and a second
input is coupled to an output of the amplifier. Thus, the chop-
per has an output signal having a frequency representative of
the local temperature and an amplitude representative of the
thermocouple temperature, whereby the combined signals
represent the true temperature of the part.

21 Claims, 10 Drawing Sheets







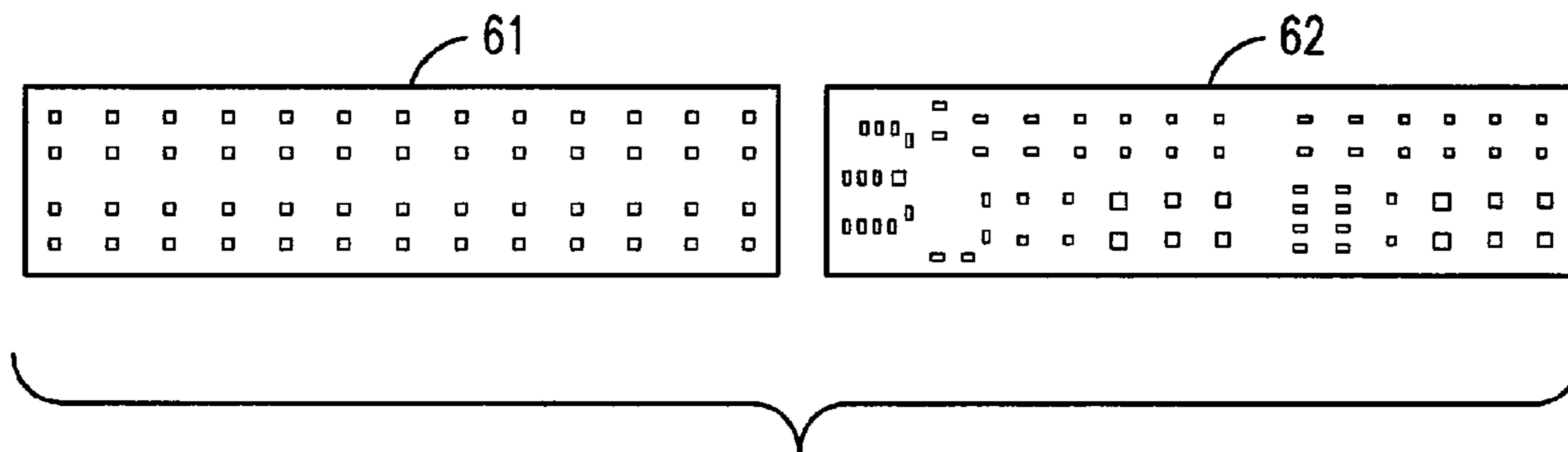


FIG. 4B

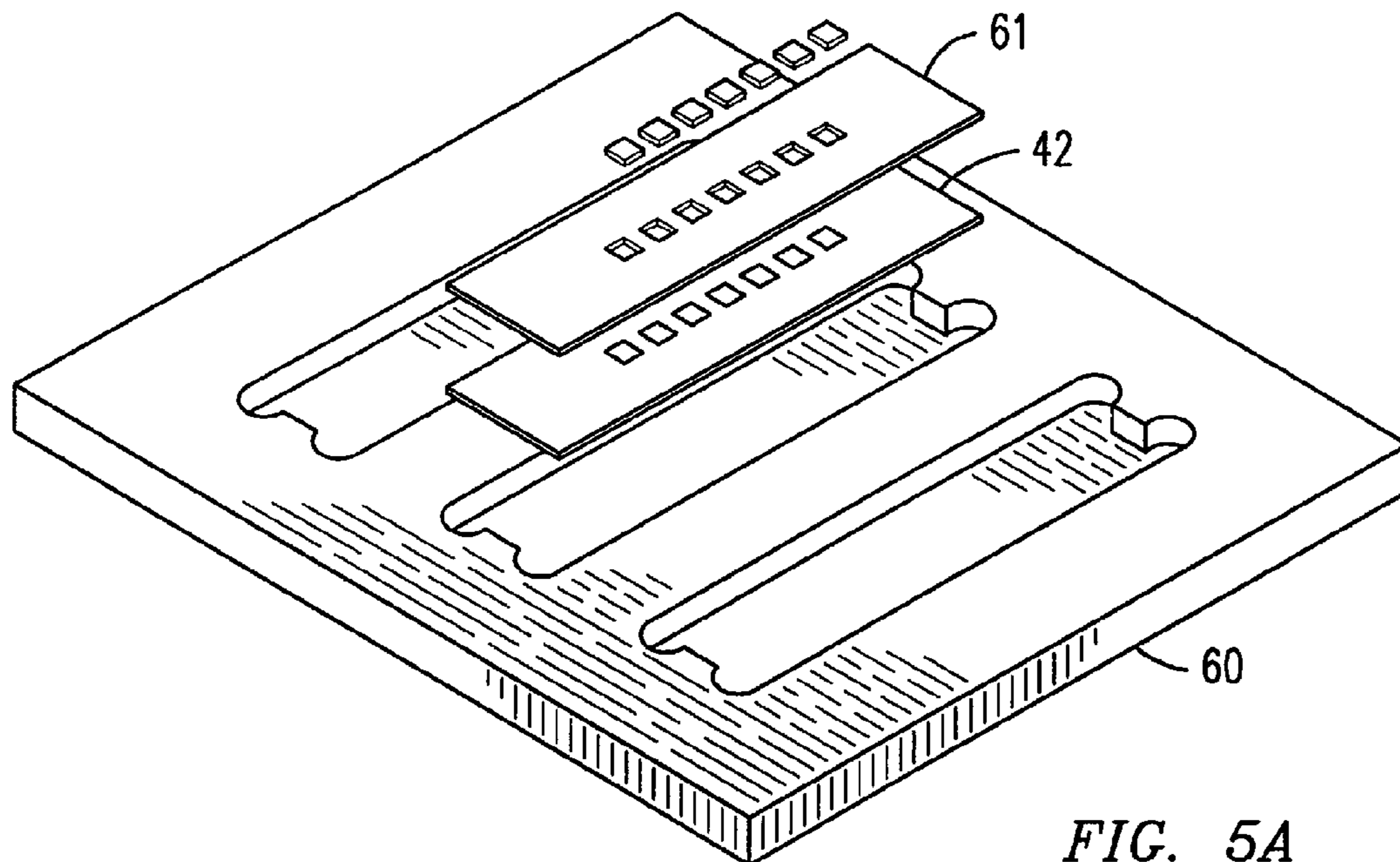


FIG. 5A

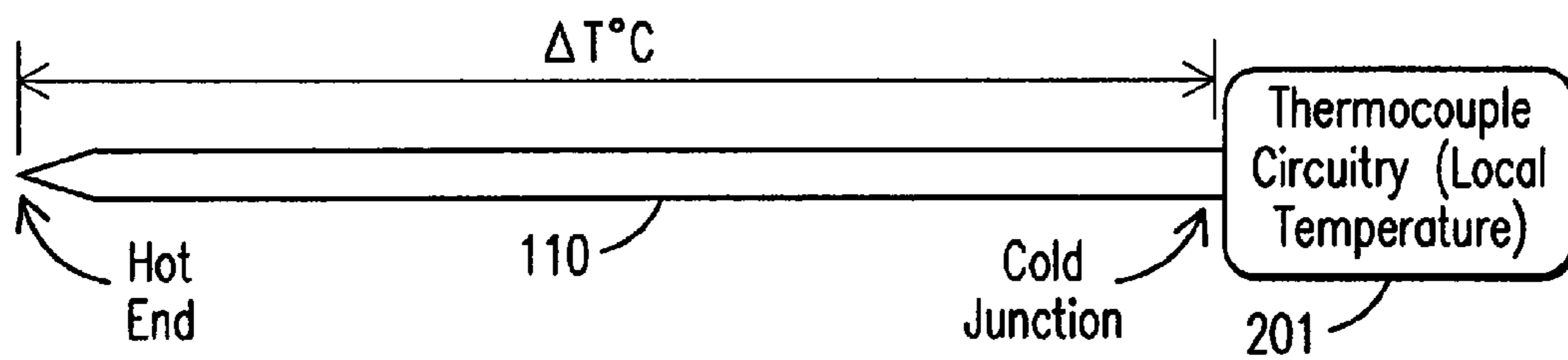
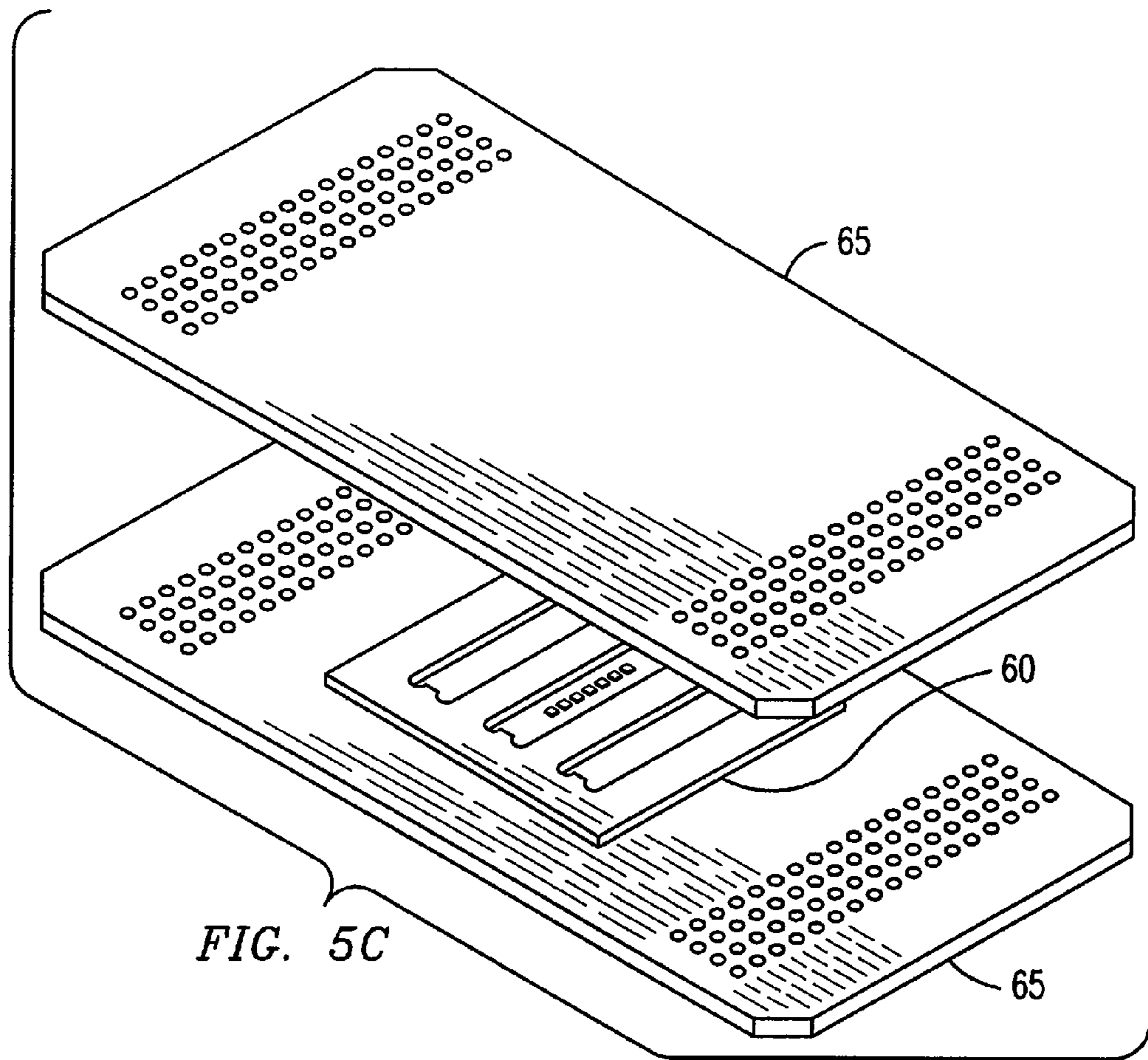
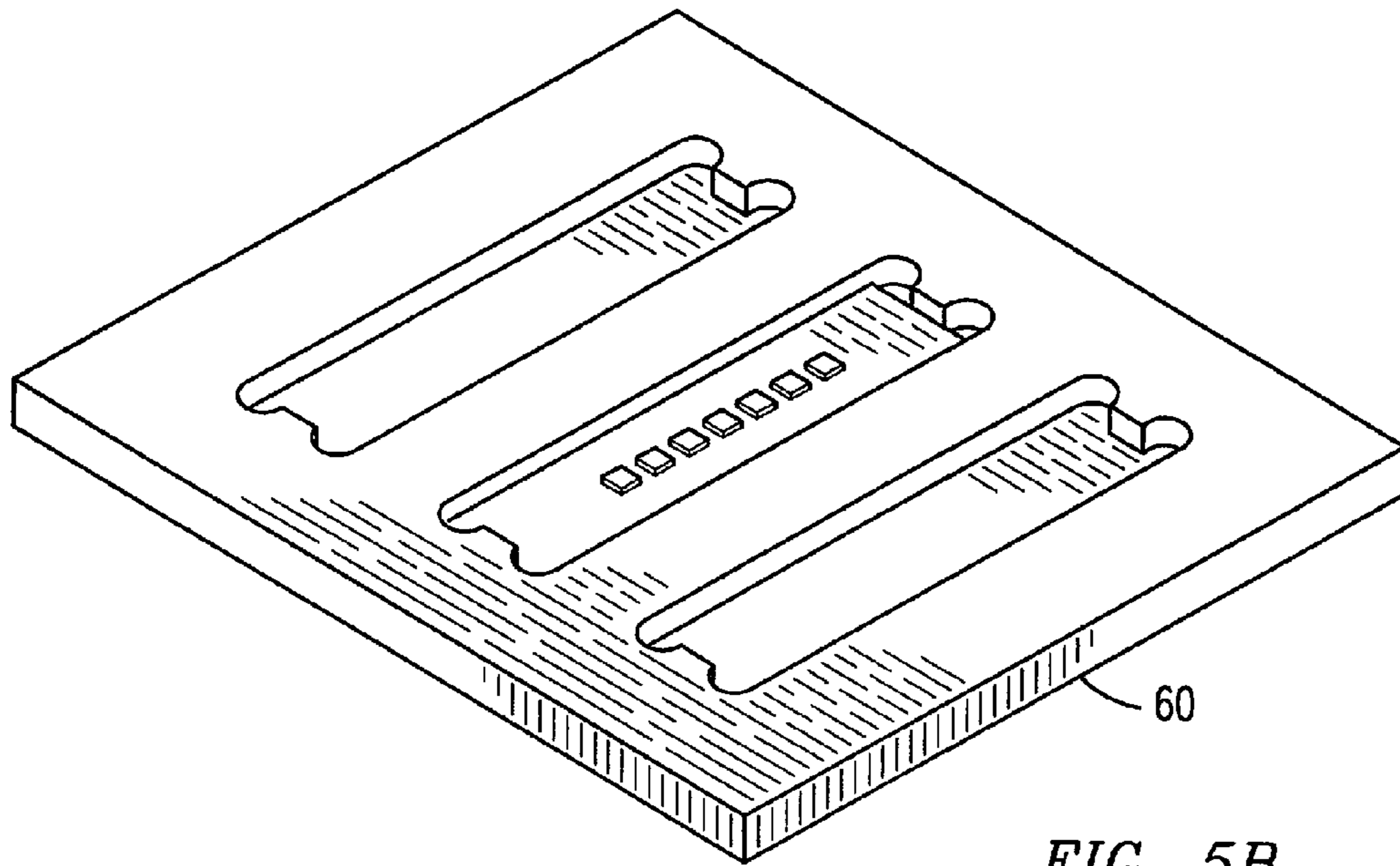


FIG. 16



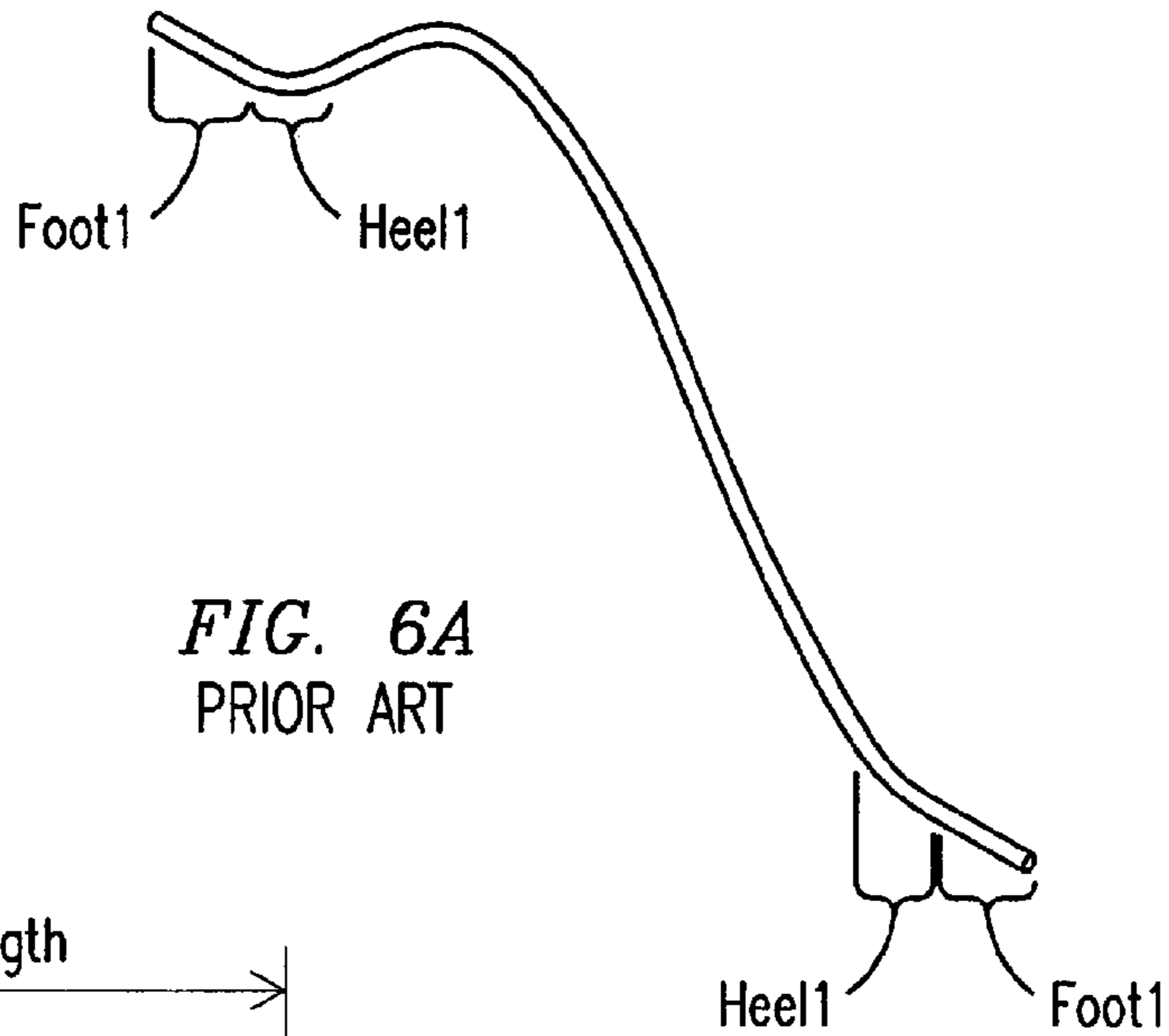


FIG. 6A
PRIOR ART

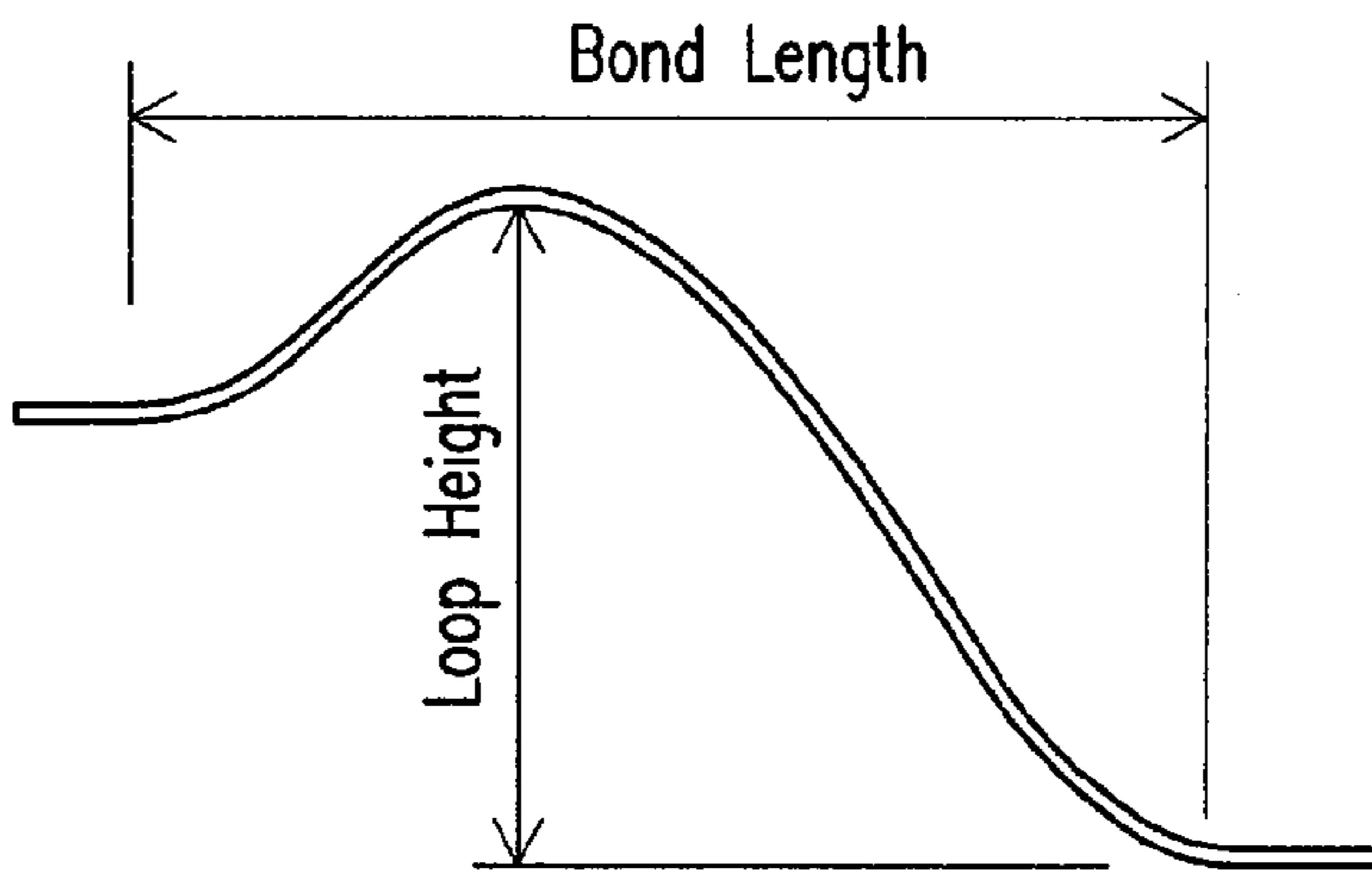


FIG. 6B
PRIOR ART

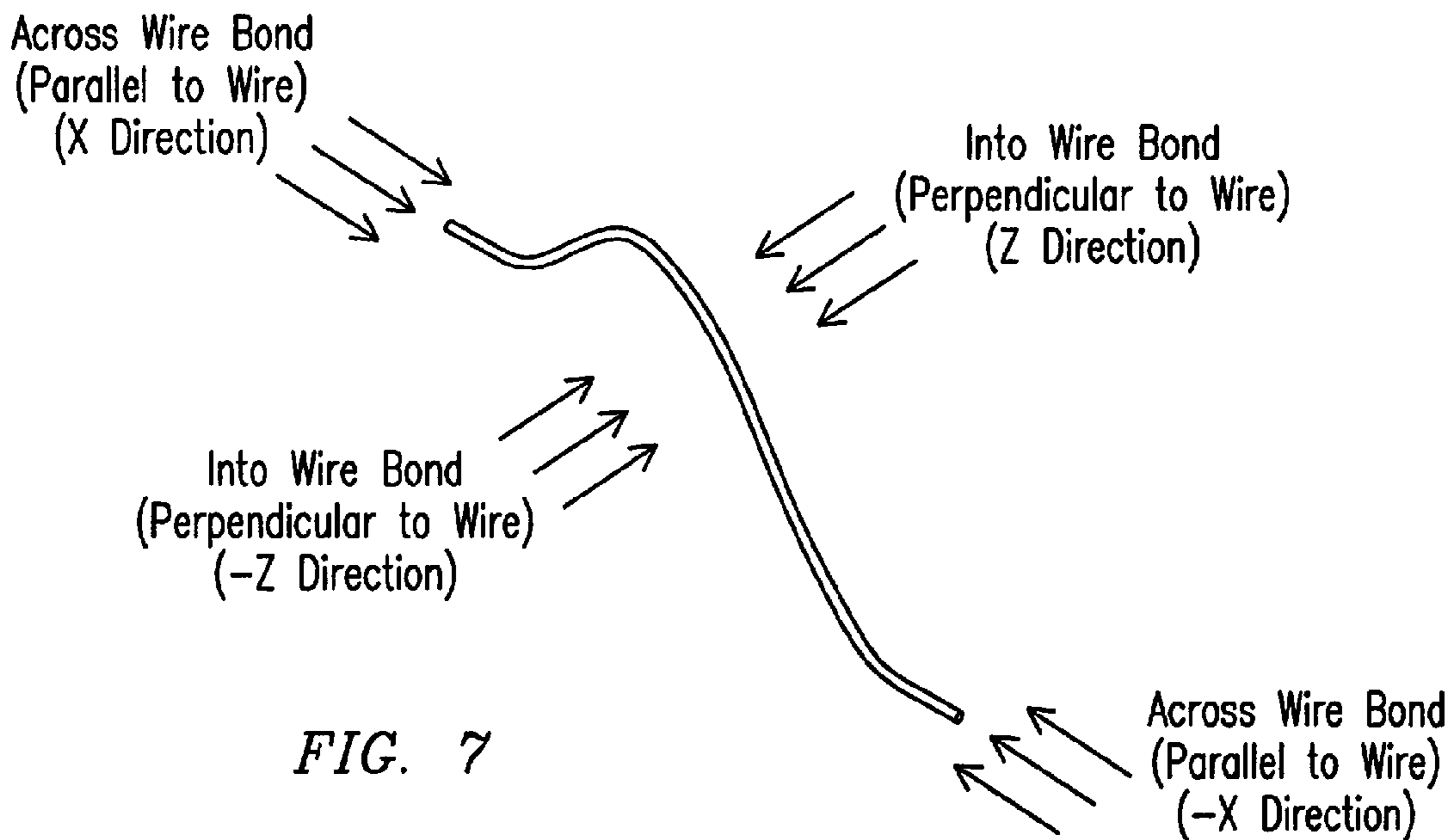


FIG. 7

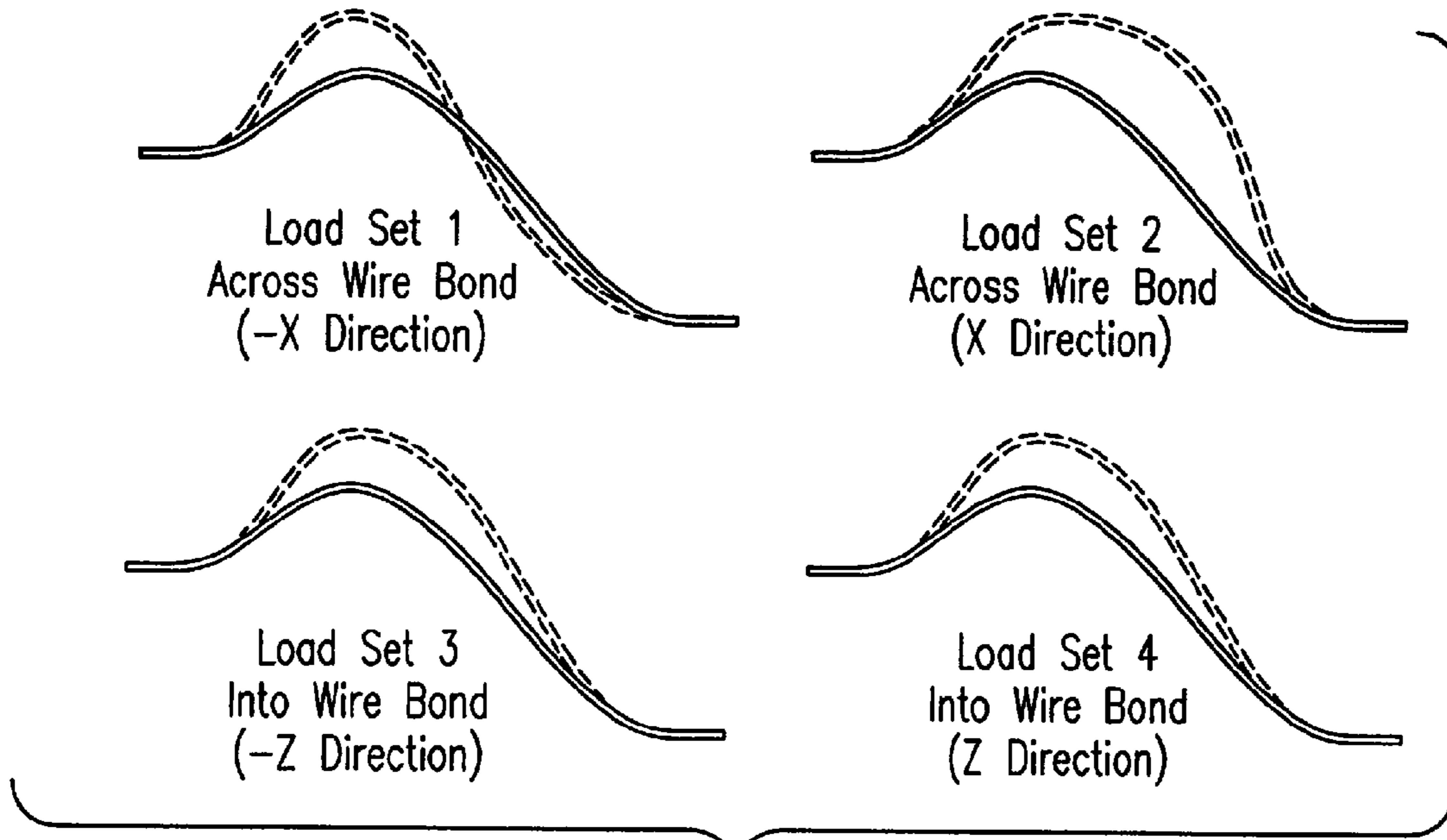


FIG. 8

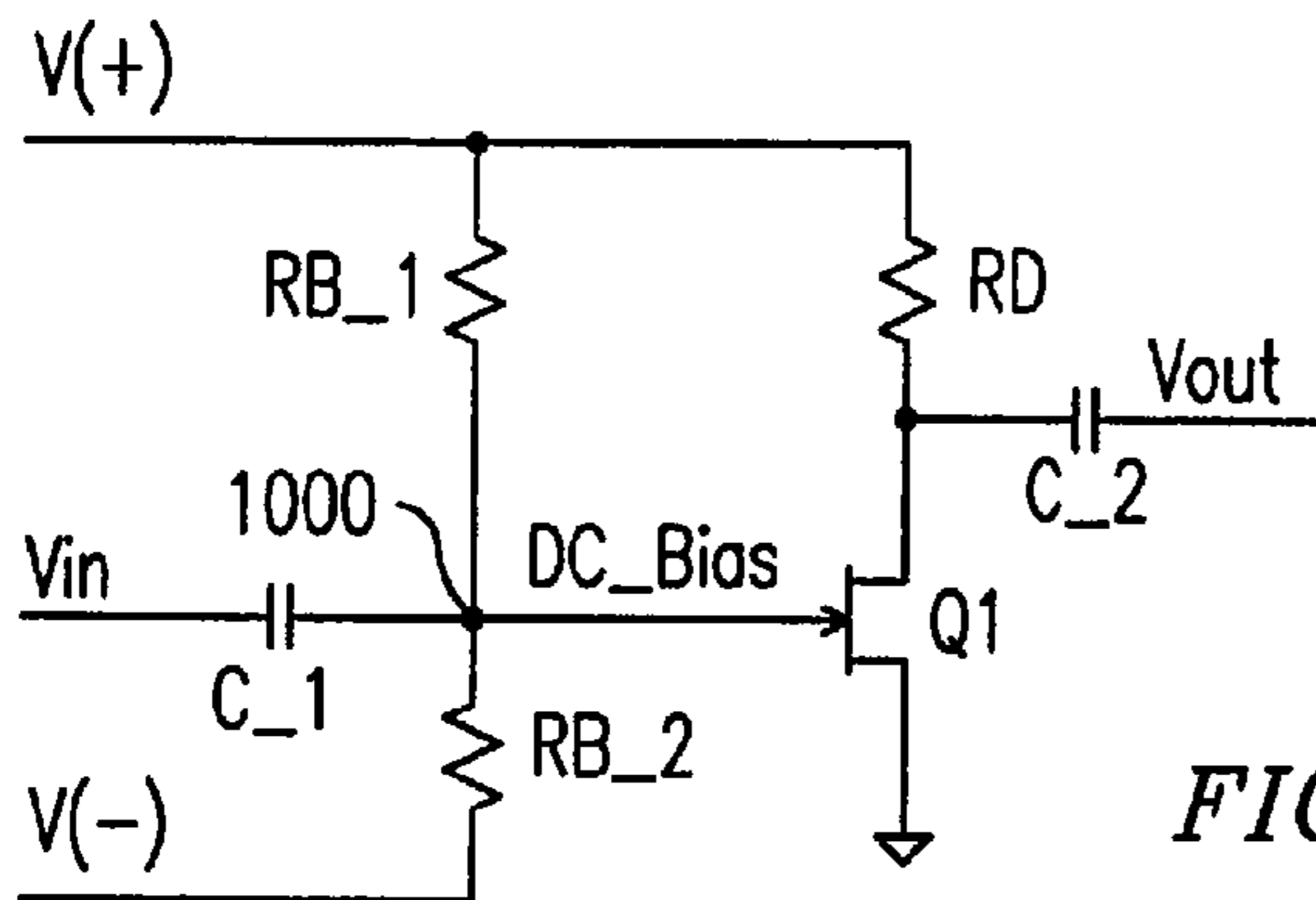


FIG. 9A

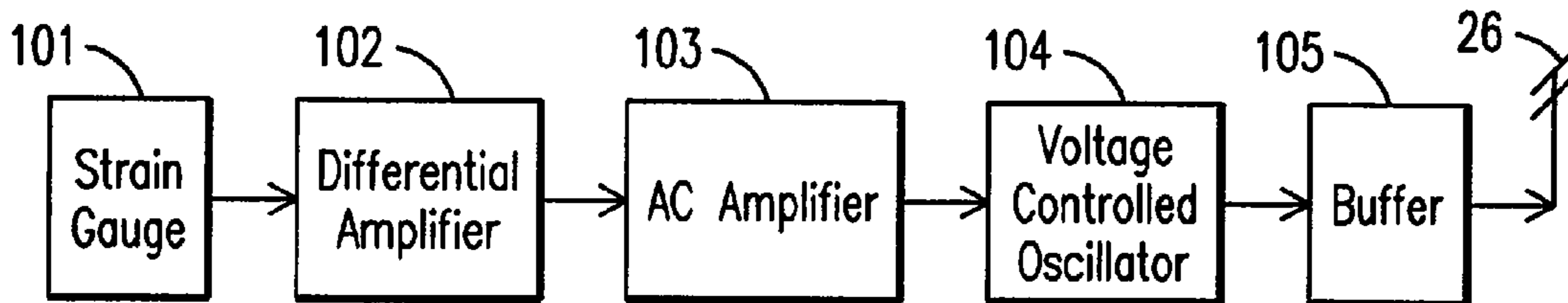


FIG. 10

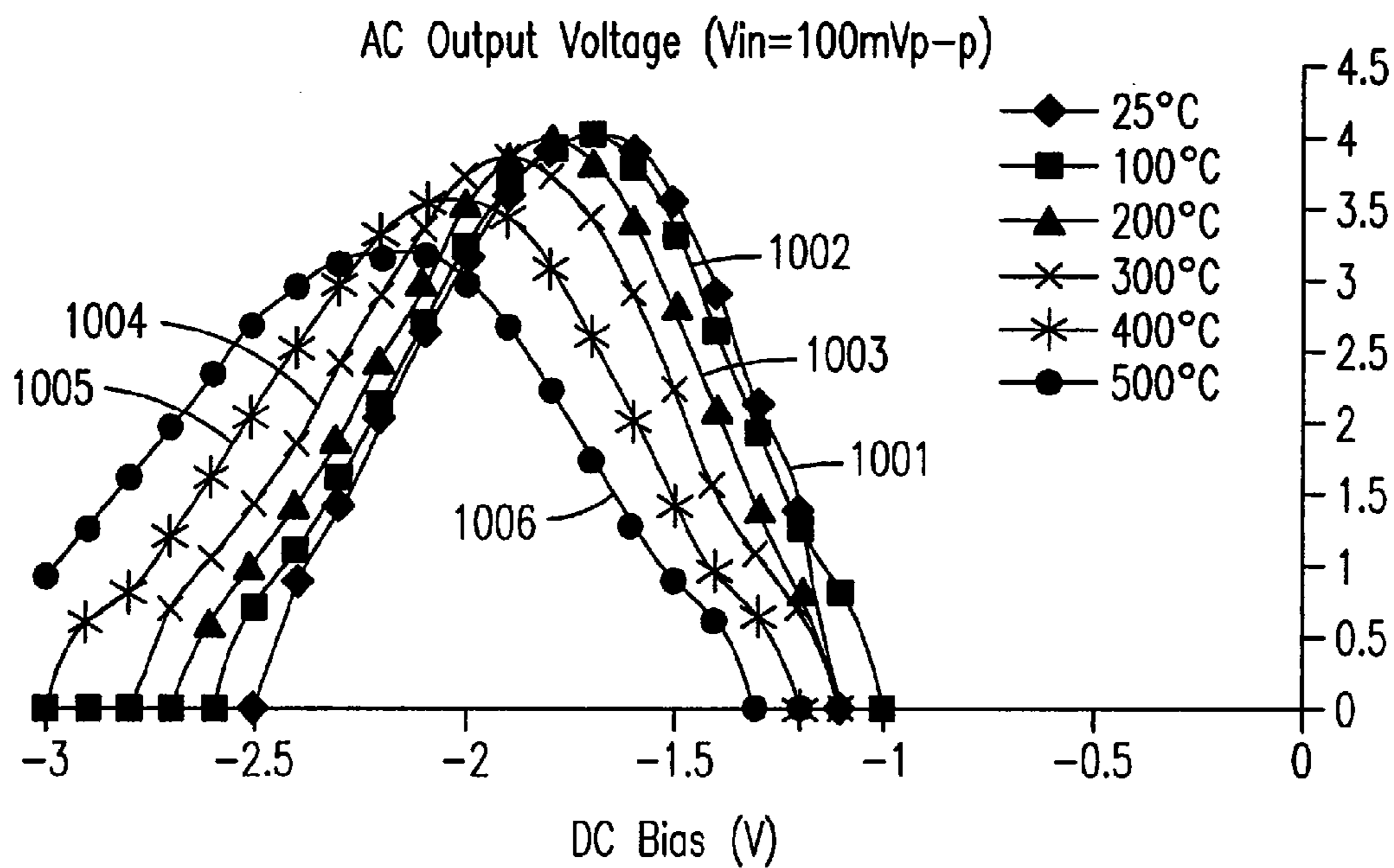


FIG. 9B

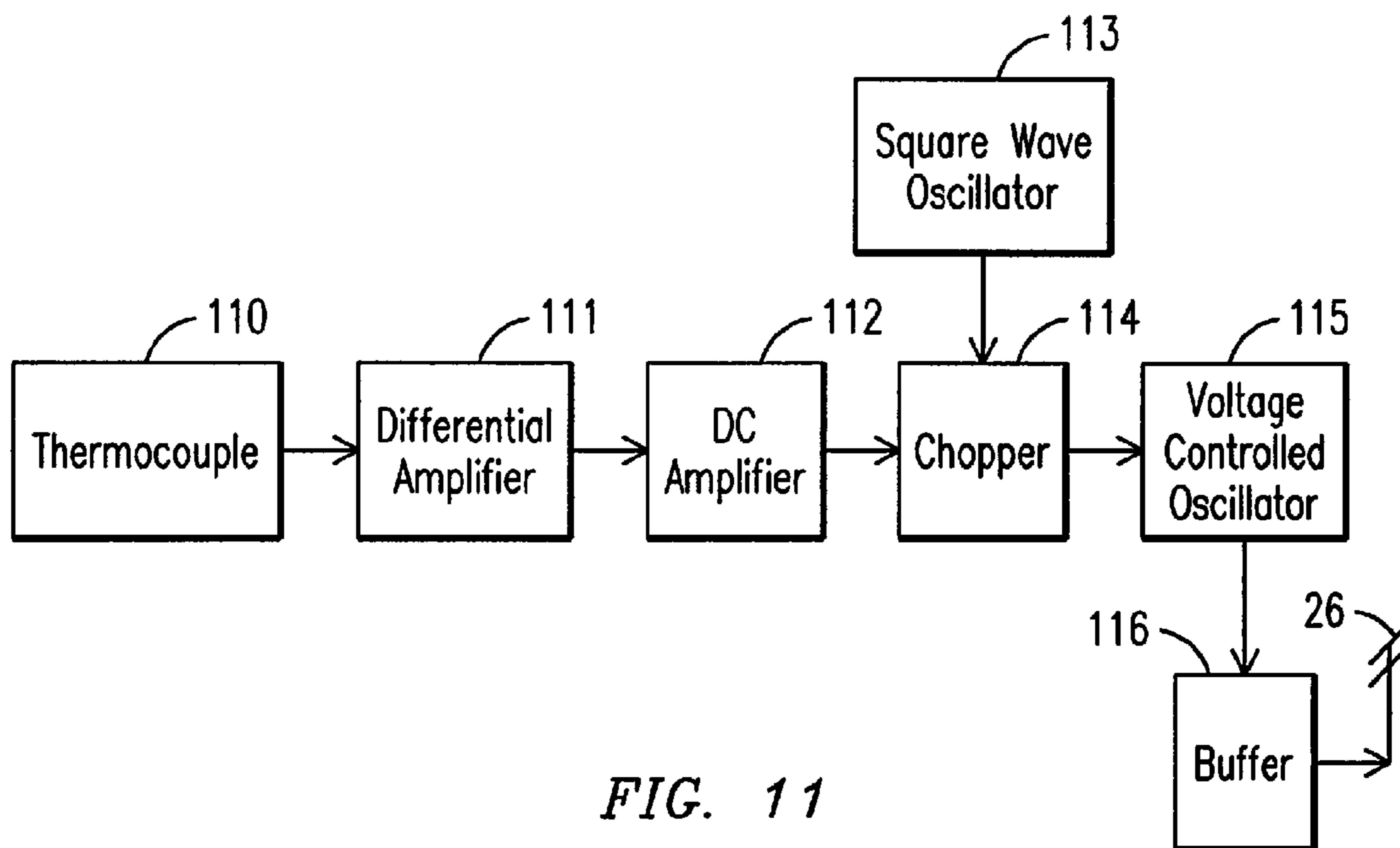


FIG. 11

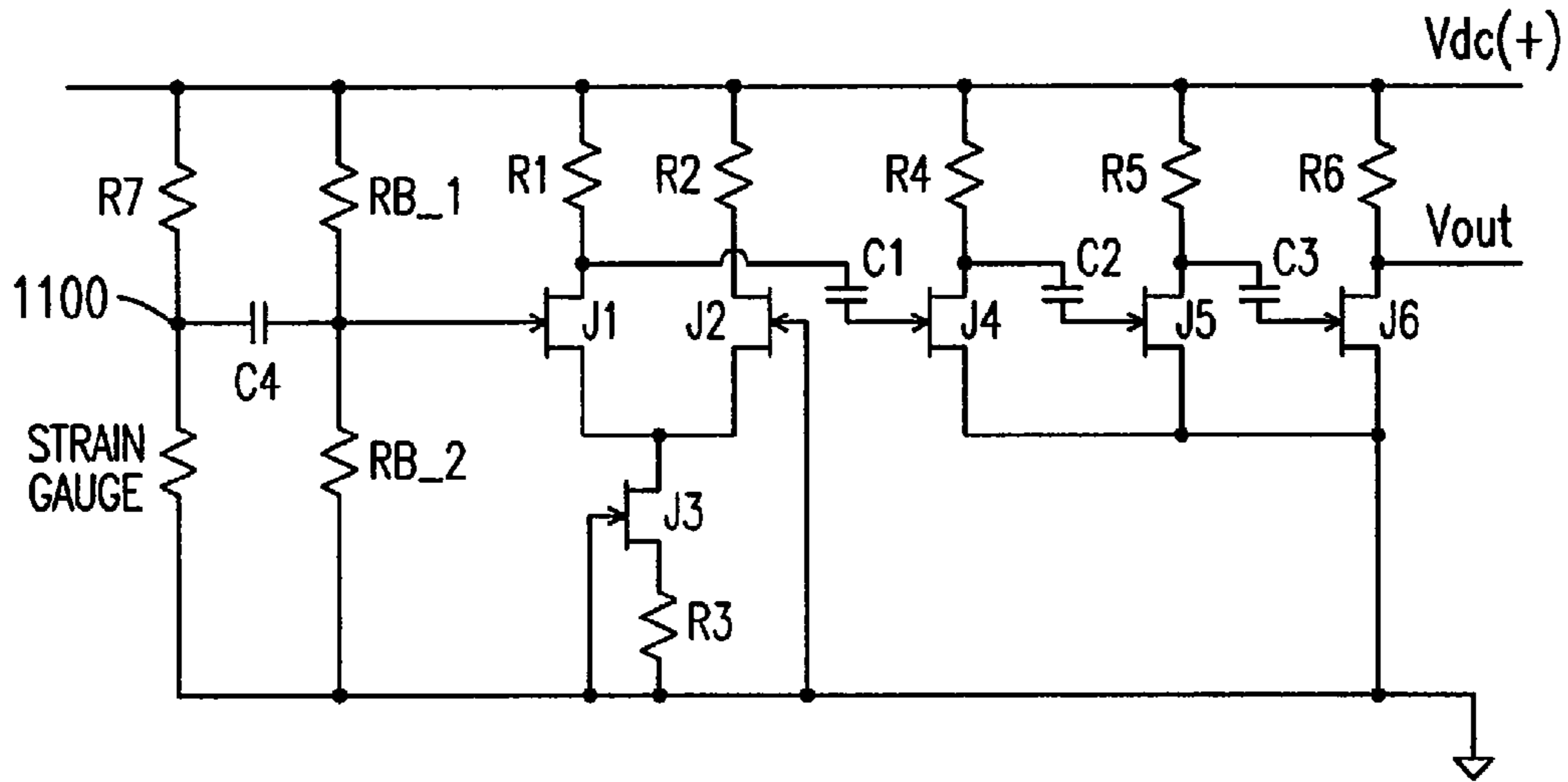


FIG. 12

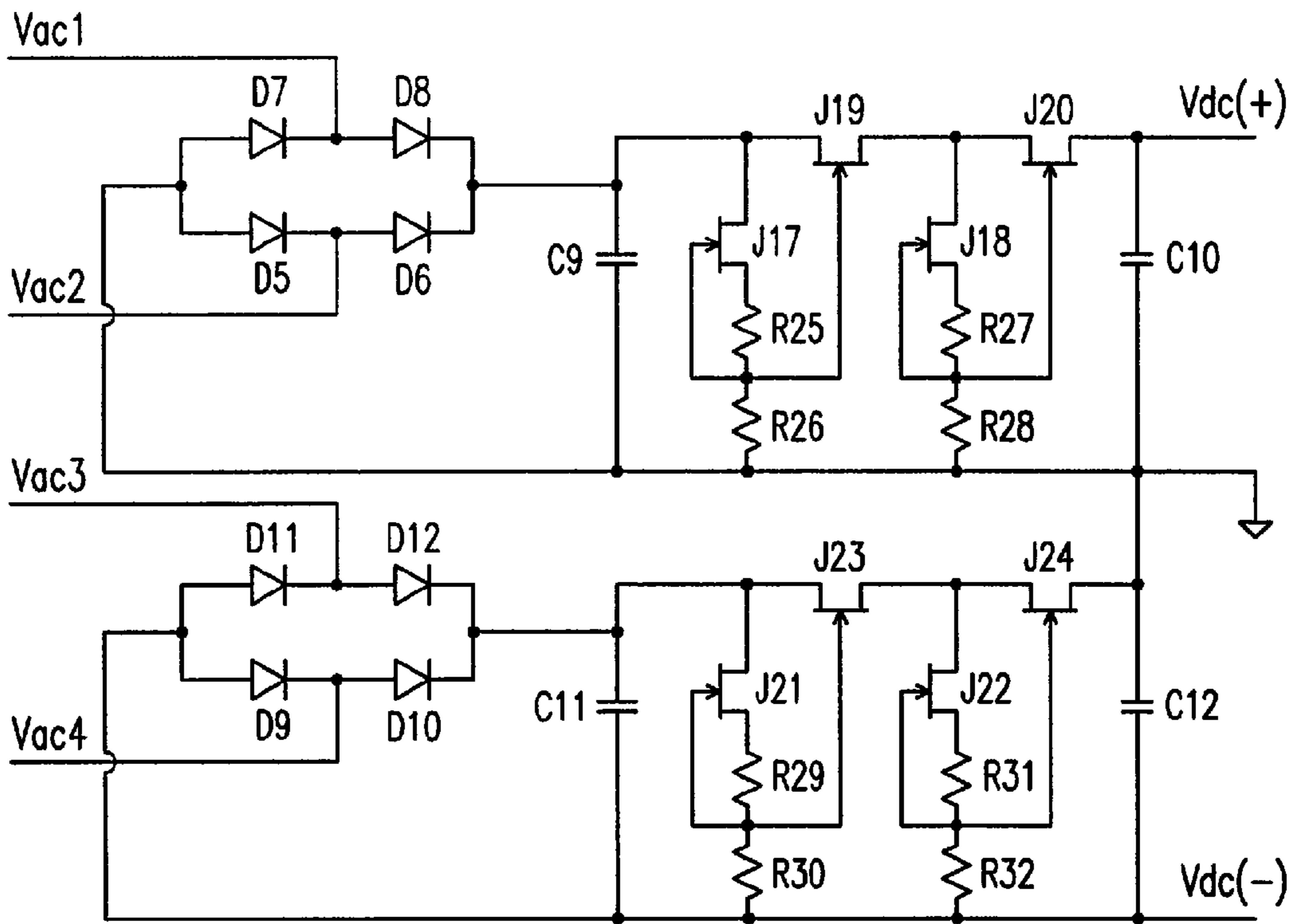


FIG. 14

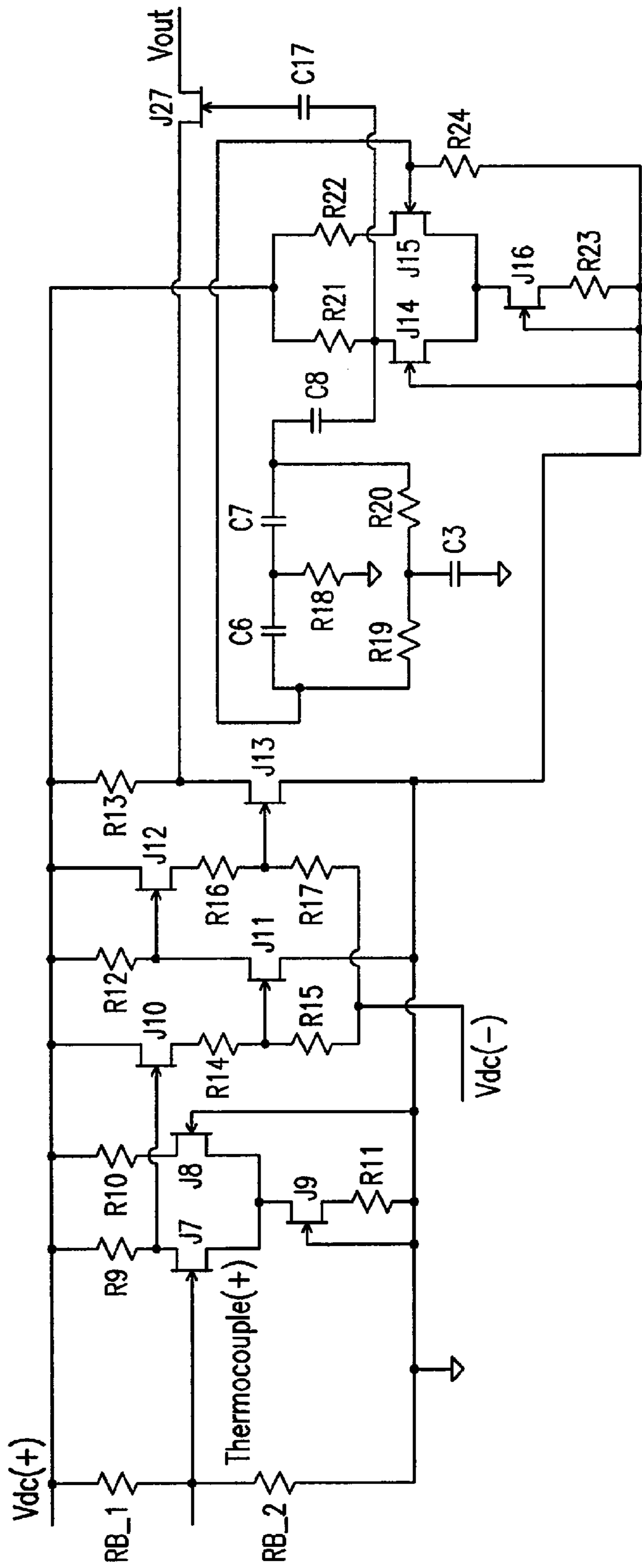


FIG. 13

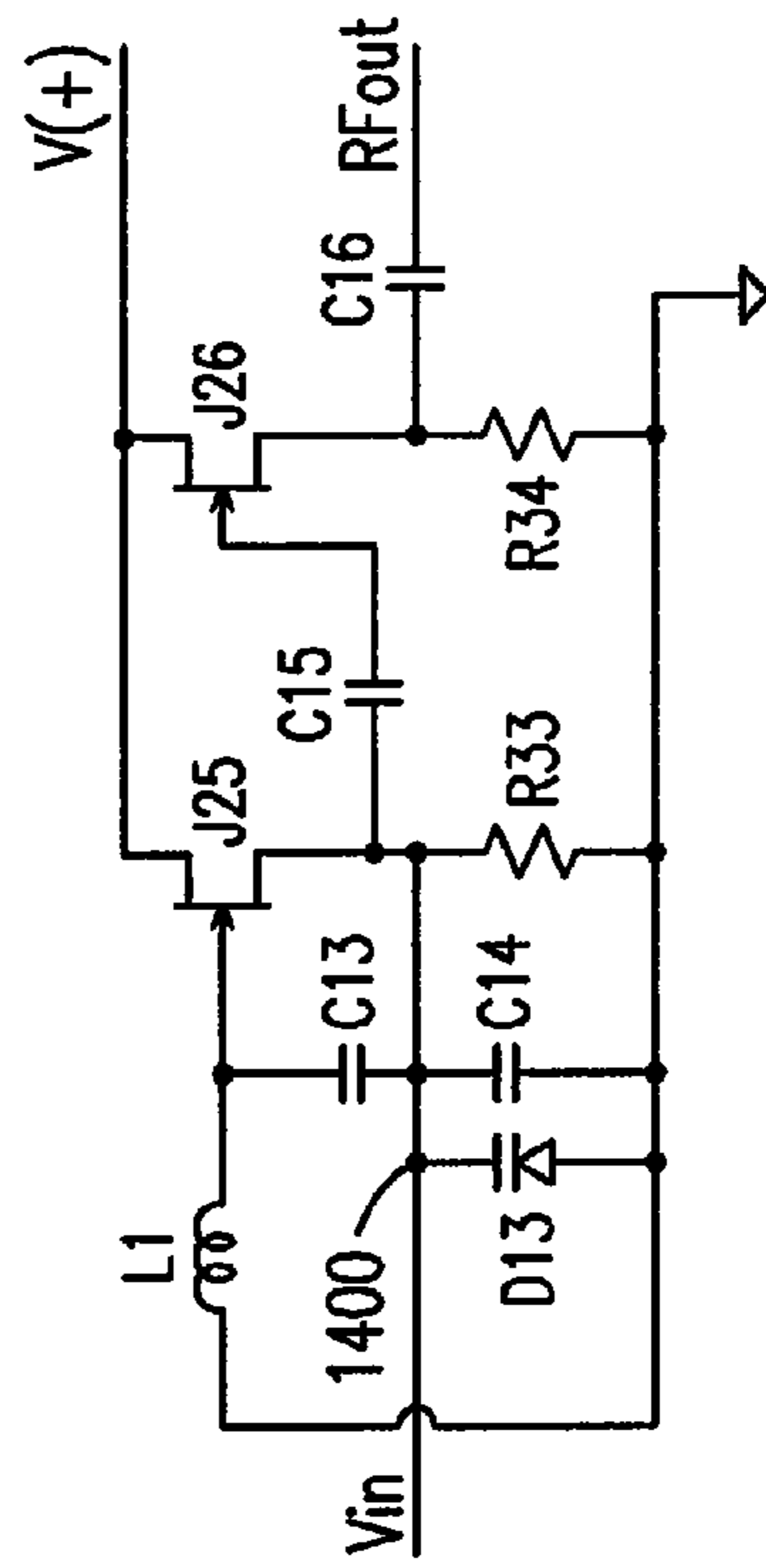
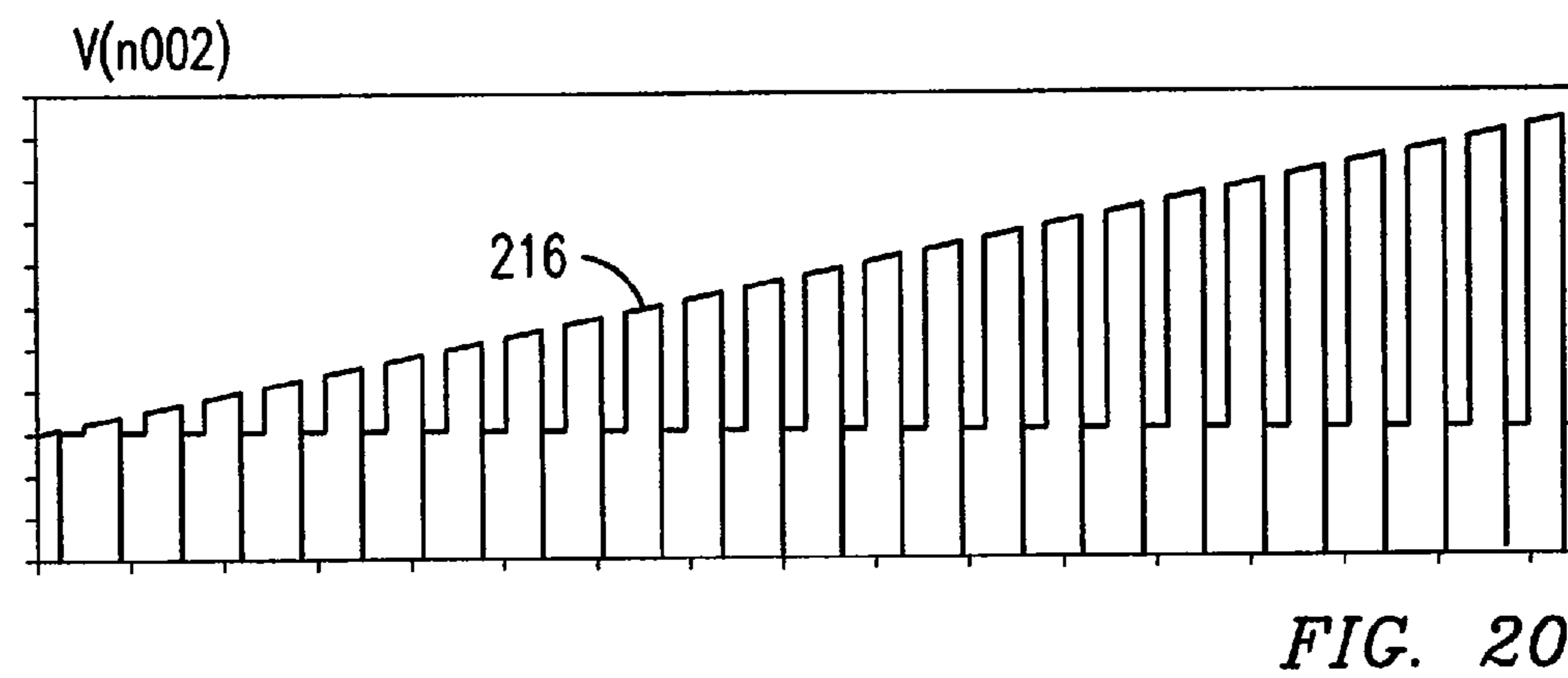
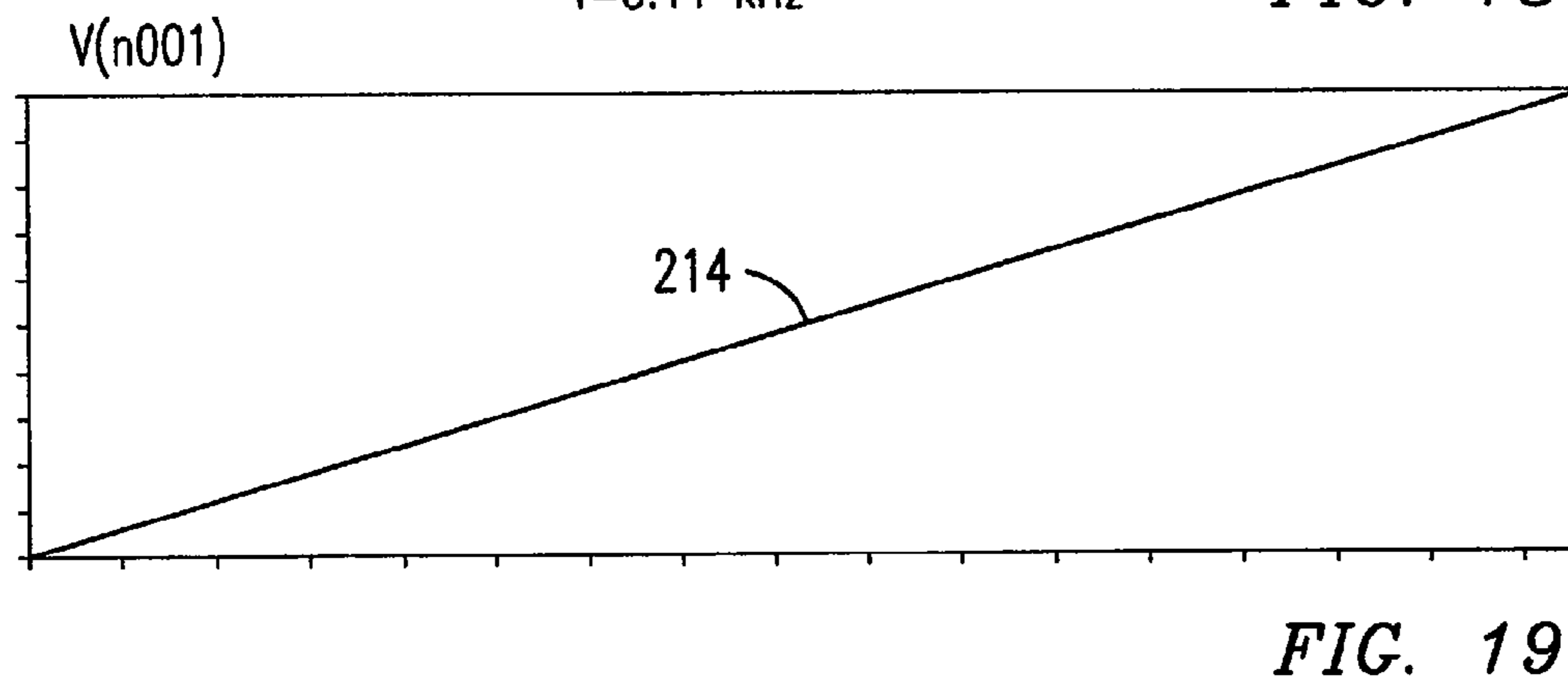
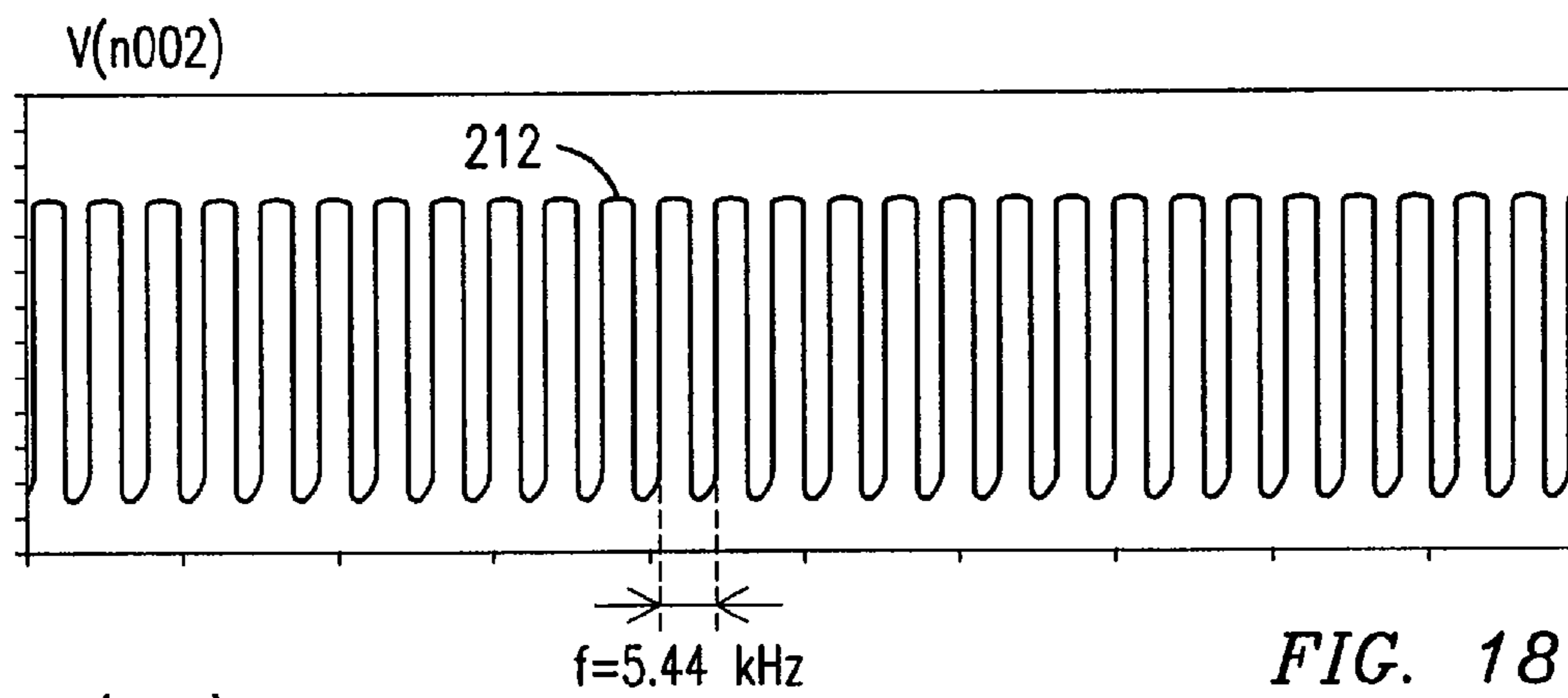
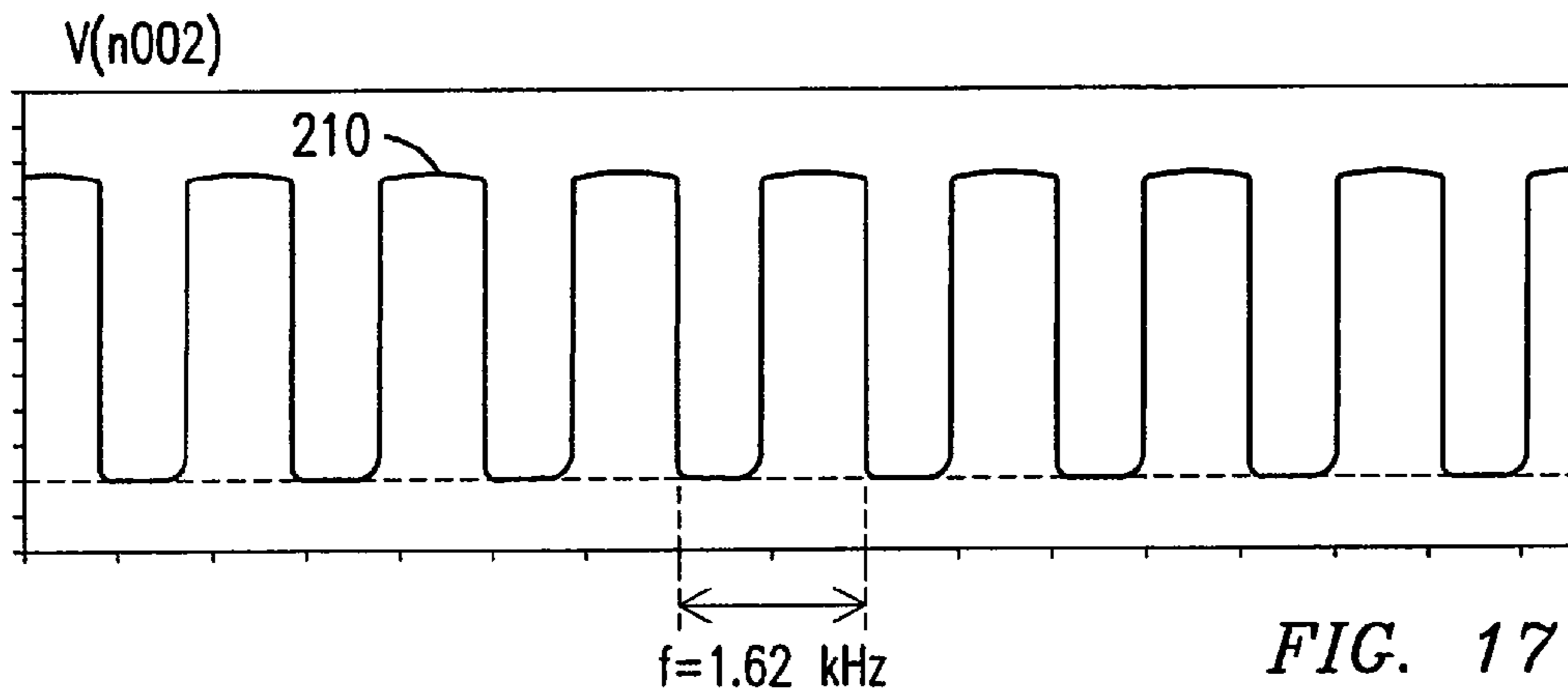


FIG. 15



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**WIRELESS TELEMETRY CIRCUIT
STRUCTURE FOR MEASURING
TEMPERATURE IN HIGH TEMPERATURE
ENVIRONMENTS**

STATEMENT REGARDING FEDERALLY
SPONSORED DEVELOPMENT

Development for this invention was supported in part by Contract No. 70NANB4H3042, awarded by the National Institute of Standards and Technology. Accordingly, the United States Government may have certain rights in this invention.

FIELD OF THE INVENTION

The present invention generally relates to wireless telemetry electronic circuitry for measuring component temperature and in particular to electronic circuitry that is capable of operating in high temperature environments exceeding 300° C. and capable of withstanding forces up to at least 1000 g's.

BACKGROUND OF THE INVENTION

The temperatures inside an operating gas turbine engine are extremely high, often at levels in excess of 450° C. When it is desirable to monitor the inside temperatures of components of the turbine, such as a turbine blade, or to monitor stresses placed upon such components during operation, a special sensing, amplifying and transmitting circuit is required. An effective solution to this problem is the use of wireless telemetry, such as that disclosed in published U.S. Patent Application Publication No US 2005/0198967 A1 entitled SMART COMPONENT FOR USE IN AN OPERATING ENVIRONMENT; or U.S. application Ser. No. 11/936,936 entitled INSTRUMENTED COMPONENT FOR COMBUSTION TURBINE ENGINE and U.S. application Ser. No. 11/521,193 entitled INSTRUMENTED COMPONENT FOR WIRELESS TELEMETRY.

In these above-cited patent applications, the general concept of using wireless telemetry is disclosed. The present patent application addresses specific problems encountered when implementing such technology.

Wireless telemetry circuit boards and components thereon that can withstand high temperatures can enable the extraction of data from stationary and moving components in high temperature environments, such as those experienced in internal combustion gas turbine engines. Electronic circuitry offer the possibility for real-time monitoring of component conditions during operation of turbine engines, such as industrial gas turbines, aircraft engines, and turbines used in the oil and gas industry. Knowing the condition of components in a turbine offers many benefits, including optimizing turbine operation based on internal engine parameters and enabling condition-based maintenance. Significant reductions in operation costs of advanced turbine engines may be realized by the use of monitoring devices. The current practice of instrumenting turbine components involves mounting sensors to components, running lead wires to routers and bringing large bundles of lead wires long distances out of the turbine to a monitoring location. The process is slow, labor intensive, expensive, and requires modification of many of the components of the turbine in order to allow for the inclusion of all of the lead wires.

In order to realize the advantage of extracting data from such a sensor system, it may be required to place the data transmitter on the coolest region of a hot component. This

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could result in the need for a wireless telemetry system that would function at temperatures exceeding 300° C., such as at the root of a blade in the flow path of a turbine engine. Current state of the art circuits using silicon or silicon-on-insulator (SOI) active components are not capable of operation at such high temperatures. Such a wireless telemetry circuit board would require a package, a board, runs, passive devices, active devices and connections capable of operating at temperatures exceeding 300° C.

BRIEF DESCRIPTION OF THE DRAWINGS

The invention is explained in the following description in view of the drawings that show:

FIG. 1 is a partial perspective view of an exemplary turbine blade illustrating attachment of electronics including the telemetry circuit board.

FIG. 2 is an exploded perspective view showing elements of the transmitter assembly of FIG. 1.

FIG. 3 is an exploded view showing the elements within the high temperature electronics package included in the transmitter assembly housing of FIG. 2.

FIG. 4A illustrates plan and side views of a transfer plate for securing the circuit boards during the assembly operation.

FIG. 4B is a plan view of the alignment plates to be used with the transfer plate of FIG. 4A for securing components in place during the assembly operation.

FIGS. 5A, 5B and 5C are perspective views of the assembly process using the transfer plate and alignment plate of FIGS. 4A and 4B.

FIGS. 6A and 6B are views of wire bonding techniques typically used in the semiconductor arts.

FIG. 7 is a perspective view showing g-force analysis of a typical wire bonding.

FIG. 8 illustrates various conditions of the wire bonding under simulated g-force stress.

FIG. 9A is an exemplary schematic diagram illustrating the unique circuit biasing for amplifier circuits used herein.

FIG. 9B is a chart illustrating the AC output voltage versus bias voltage of the amplifier of FIG. 9A under varying temperatures

FIG. 10 is a block diagram of the strain gauge circuitry.

FIG. 11 is a block diagram of the thermocouple circuitry.

FIG. 12 is a schematic diagram of the circuit for amplifying a strain gauge output signal.

FIG. 13 is a schematic diagram of the circuit for amplifying a thermocouple output and embedding the local temperature of the transmitter into the amplified output signal.

FIG. 14 is a schematic diagram of the power conditioning circuitry.

FIG. 15 is a schematic diagram of the FM transmitter including a Colpitts oscillator.

FIG. 16 is a diagram of a representative thermocouple.

FIG. 17 is a waveform diagram illustrating the output of the square wave generator for the thermocouple circuitry at room temperature.

FIG. 18 is a waveform diagram illustrating the output of the square wave generator for the thermocouple circuitry at elevated temperature.

FIG. 19 is a waveform diagram illustrating the output voltage of the thermocouple as temperature is increased.

FIG. 20 is a waveform diagram illustrating the output of the chopper, which is the combined output of the thermocouple and the square wave generator.

DETAILED DESCRIPTION OF THE INVENTION

Embodiments disclosed herein enable transmission of data via wireless telemetry by the use of an electronic circuit from

regions of a gas turbine with temperatures ranging from ambient to greater than 300° C., and including temperatures up to at least 450° C. All of the elements of the circuit and package therefore are to be fabricated from materials capable of operation at temperatures greater than 300° C. Current state of the art high temperature electronic systems are designed such that the control logic circuits are placed in a location cool enough to use silicon-based electronics, or high temperature silicon-on-insulator (HTSOI) technology capable of operation at elevated temperatures up to a maximum of 300° C. In such a current state of the art system, the control signals are sent from a region of relatively low temperature, via a wire, to a power amplification module that is located in the hot region, at temperatures greater than 300° C. The power amplification module is a circuit that would employ semiconductors designed for high temperature use, such as wide band gap semiconductor materials including SiC, AlN, GaN, AlGaIn, GaAs, GaP, InP, AlGaAs, AlGaP, AlInGaP and GaAsAlN, or other high temperature capable semiconductor materials that may be used at temperatures greater than about 300° C. This type of design strategy is not useful for incorporating instrumentation on a rotating hot section component, such as a gas turbine blade, because the entirety of the transmitter electronic circuitry must be located on the turbine blade, and thus operate at temperatures exceeding 300° C. New electronic circuits are disclosed herein that enable both sensor signal acquisition and wireless transmission at temperatures greater than 300° C. and including temperatures up to at least 450° C.

The disclosed electronic circuit and package therefore are fabricated from materials capable of operation at high temperature, for example temperature capable epoxy or ceramic materials, such as alumina, zirconia, silicon carbide, silicon nitride, aluminum nitride, etc. The conductors are fabricated from metals that can withstand high temperature without melting, such as silver or gold. Active and passive electrical components must be selected based upon the electrical requirements and the temperature environment in which the board will operate. High temperature passive components, such as thick film resistors based on systems such as palladium, ruthenium, iridium, rhenium, multilayer ceramic capacitors such as NP0, COG and X7R may be employed. High temperature capable inductors may need to be deposited directly onto the PC board supporting the electronic circuit, if suitable inductors are not commercially available. The active components, i.e., transistors, diodes, etc., may be fabricated from semiconductor materials capable of operating at high temperatures, such as those listed above. Connections between components and the electronic circuitry could likewise be made from high temperature metals, such as gold or aluminum in the form of die attach, wire bonding, or any other appropriate method. In the case where the limits of monolithic high temperature bonding materials are exceeded, attachment may be performed using alloy compositions. In order to reduce the temperature to which the devices are exposed during attachment, a eutectic alloy composition may be used for attachment, followed by a heat treatment to change the attachment composition to one with a higher melting temperature. All materials on the board must be selected such that exposure to the required operating temperatures does not result in chemical interactions or compositional/structural changes that degrade the performance of the board. A complete circuit capable of transmitting a signal from a thermocouple or strain gauge sensor has been designed in accordance with the present disclosure using the types of high temperature passive and active electronic materials that are currently available or are under development.

With reference to FIG. 1, embodiments of the present invention allow for transmitting sensor data from a rotating component, such as a turbine engine blade **20** having certain electronic components located on root **22** of the blade, which operates in an environment having a temperature exceeding 300° C. For purposes of the disclosure herein, the term “high temperature” without additional qualification will refer to any operating environment, such as that within portions of a combustion turbine, having a maximum operating temperature exceeding 300° C.

Embodiments of the present invention provide components for use in a combustion turbine instrumented with telemetry systems that may include one or more sensors, lead lines connecting sensors with at least one telemetry transmitter circuit, at least one transmitting antenna, a power source and at least one receiving antenna. FIG. 1 illustrates the turbine blade **20**, a wireless telemetry transmitter assembly **24** and a rotating antenna assembly **26**. Lead lines or connectors **28** may extend from one or more sensors, such as sensor **30**, to telemetry transmitter assembly **24** when mounted proximate blade root **22**. Lead lines **28** may route electronic data signals from the sensor **30** to telemetry transmitter assembly **24** where the signals are processed by a telemetry transmitter circuit formed on a circuit board contained within an electronics package **34** shown in FIG. 2. Lead lines or electrical connectors **36** may be deposited for routing electronic data signals from a telemetry transmitter circuit to the rotating antenna assembly **26**.

FIG. 2 illustrates a high temperature electronics package **34** that may contain a high temperature circuit board and form part of telemetry transmitter assembly **24**. The main body of electronics package **34** may be fabricated from alloys with low thermal expansion coefficient such as Kovar® brand alloy, an alloy of Fe—Ni—Co. The thermal expansion coefficient of Kovar® alloy ranges from about $4.5\text{--}6.5 \times 10^{-6}/^\circ\text{C}$., depending on exact composition. The Ni-based alloys typically used for high temperature turbine components, such as turbine blade **20** have thermal expansion coefficients in the range of about $15.9\text{--}16.4 \times 10^{-6}/^\circ\text{C}$. Electronics package **34** may be affixed securely in place while allowing for relative movement between electronics package **34** and turbine blade **20**, as described below with respect to FIG. 2. This relative movement may result from their different thermal expansion rates, which occur over time during the high number of thermal cycles between ambient air temperature and the greater than 300° C. operating temperature typically experienced proximate blade root **22**.

The telemetry transmitter assembly **24**, as best shown in FIG. 2, may include a mounting bracket **37** and a lid or cover plate **38** with electronics package **34** positioned there between. A plurality of connecting pins **40** enable connection between an electronic circuit board contained within package **34**, such as one having a wireless telemetry circuit fabricated thereon, and various external devices such as lead lines from sensors, induction coil assemblies or data transmission antennae. Mounting bracket **37**, cover plate **38** and retention screws **39** connecting them together (shown in FIG. 1) may all be fabricated from the same material as is turbine blade **20**. This ensures there is no difference in thermal expansion between turbine blade **20** and mounting bracket **37**. Consequently, no stresses are generated in mounting bracket **37** or turbine blade **20** during thermal transients.

The thermal expansion coefficient of electronics package **34** may be different than that of mounting bracket **37**. When the operating system within which these components reside is at a high temperature, electronics package **34**, including any circuit board contained therein, that are formed of Kovar®

alloy would expand less than mounting bracket 37, which may lead to damage caused by vibrational energy in the system. In order to secure electronics package 34 within mounting bracket 37 to accommodate the dimensional change differential between bracket 37 and electronics package 34, a layer of ceramic fiber woven fabric 41 may be placed between the electronic package 34 and the inside surface of mounting bracket 37. Fabric 41 may be fabricated from suitable ceramic fiber, including such fibers as silicon carbide, silicon nitride or aluminum oxide. For example, a quantity of Nextel™ aluminum oxide based fabric, manufactured by 3M, may be used for fabric 41.

With electronics package 34 and ceramic fiber woven fabric 41 assembled with mounting bracket 37 and cover plate 38 to form telemetry transmitter assembly 24, mounting bracket 37 may be attached to turbine blade 20 by a suitable means for attaching such as bolting, welding, brazing or via transient liquid phase bonding. FIG. 1 illustrates a recess or flat pocket 42 that may be milled or otherwise formed within turbine blade 20 proximate blade root 22 for receiving assembly 24.

Cover plate 38 may be formed with a flange 44 oriented perpendicular to the direction of G-forces, to add structural support to the cover plate, which counters the g-load forces occurring when rotating turbine blade 20 is operating at full speed. This relieves retention screws 39 from carrying the load applied to cover plate 38 via g-forces, and allows them to be made sufficiently small so that the telemetry transmitter assembly 24 fits in the relatively small recess 42 with no interference with any adjacent components. If retention screws 39 were required to carry the load applied by the G-forces, their required size would be too large to fit in the available space.

FIG. 1 shows that the rotating antenna assembly 26 may be affixed to the end face or neck of root 22. Assembly 26 may be an electronic assembly having thermal expansion coefficients different than those of the Ni-based alloys used for turbine hot gas path components such as turbine blade 20 including its root 22. One or more rotating antenna assemblies 26 may be protected from windage during rotation of turbine blade 20 at or near the speed of sound. In an embodiment, the windage protection material is transparent to RF radiation frequencies in order to enable transmission of power and data through the material. Embodiments of rotatable antenna assembly 26 may include a durable, protective, RF transparent cover 50 shown in FIG. 1, which is essentially a hollow fixture within which a data antenna and induction power components are contained. RF transparent cover 50 protects its contents from the physical effects of windage during operation of the combustion turbine. Certain ceramics are suitable for protecting RF transmission equipment from the elements at elevated temperatures. However, many ceramics and ceramic matrix composites are prone to chipping and cracking under the vibrational impact and G-loading that a rotating turbine blade 20 experiences during operation of the combustion turbine. The inventors of the present invention have determined that RF transparent cover 50 may be fabricated from an RF transparent, high toughness, structural ceramic material. Ceramic matrix composites may be used to fabricate cover 50 as well as material selected from a family of materials known as toughened ceramics. Materials such as silicon carbide, silicon nitride, zirconia and alumina are available with increased toughness due to doping with additional elements or designed microstructures resulting from specific processing approaches.

One such material that is RF transparent, easy to form, and relatively inexpensive is a material selected from a ceramic family generally referred to as zirconia-toughened alumina

(ZTA). Ceramic material selected from this family of aluminum oxide materials is considerably higher in strength and toughness than conventional pure aluminum oxide materials. This results from the stress-induced transformation toughening achieved by incorporating fine zirconium oxide particles uniformly throughout the aluminum oxide. Typical zirconium oxide content is between 10% and 20%. As a result, ZTA offers increased component life and performance relative to conventional pure aluminum oxide materials.

The designed microstructure of ZTA is fracture-resistant when the ceramic is loaded in compression. However, if loaded sufficiently in tension, the ceramic will fail catastrophically, as with traditional ceramic materials. Consequently, RF transparent cover 50 is designed so that the tensile stresses in the ceramic material are minimized during operation of the combustion turbine. This is accomplished by designing and fabricating such that (1) all corners, edges and bends of the ZTA components are machined to eliminate sharp corners and edges, in order to reduce the stress concentration factor at these locations, and (2) the orientation and fit of the ZTA component in a rotating antennae mounting bracket 51 is such that during operation the G-forces applied to the ZTA box do not generate significant bending stresses in the attachment flanges. This is accomplished by orienting the flanges parallel with the G-loading direction, rather than perpendicular to the G-loading direction, so the ZTA flange is loaded in compression and not in bending.

Mounting bracket 51 may be designed so that all the G-loading experienced by rotating antenna assembly 26 during operation of the combustion turbine is absorbed in a direction extending toward the upper end of the bracket 51. No portion of the mounting bracket 51 extends far enough past an antenna contained therein to attenuate the RF transmission data signal. RF transparent cover 50 is secured in place so its internal stress field is primarily compressive and may be retained using threaded pins (not shown) through semicircular divots on its flanges.

Mounting bracket 51 may be attached to a face of the turbine blade 22 via conventional means such as welding, brazing, bonding, bolting or screwing. An embodiment of rotating antenna assembly 26 may be assembled by placing desired antennae into the hollow body of cover 50 containing the antennae with a ceramic potting material. The potted RF transparent cover 50 containing the antennae may then be slid into mounting bracket 51, which may have been previously affixed to turbine blade root 22. Cover 50 may be secured to the mounting bracket 51 via pins inserted in the mounting bracket 51 and divots in the cover 50.

Referring now to FIG. 3 an exploded view showing the elements within the high temperature electronics package 34 included within the housing 24 of FIG. 2, is shown. Package bottom cavity 34A includes electrical connecting pins 40 extending from an end thereof, which connectors enable communication between the electronics inside the package 34 and external sensors, sources and antennae. In order to function at high temperatures up to at least 450° C., the package must be designed and sized to contain the electronic circuit and its substrate, hereinafter PC board 42. The package must be able to withstand the temperature and centrifugal loading requirements and protect the circuitry on the substrate. Hence, the package 34 is made of gold-plated Kovar® alloy and the electrical connecting pins 40 are made of gold. The gold plating on the package 34 prevents oxidation of the Kovar® alloy, which can occur at elevated temperatures. The connectors 40 are insulated from the package by means of individual insulating sleeves (not shown). A pair of the pins 40 is coupled to electrical connectors 28, which communicate with the sen-

sor **30**. A third pin is coupled to ground potential, while pins **4**, **5**, **6** and **7** are coupled to a source of power (two each for positive and negative ac). The last pin is used for coupling the transmitter output (data) signal to the antenna **26**.

PC Boards

The PC board **42** or substrate is preferably fabricated from material capable of operation at high temperatures, such as high temperature capable epoxy or ceramic materials, such as alumina, zirconia, silicon carbide, silicon nitride, aluminum nitride, etc. The circuit runs (or "printed circuits") are preferably fabricated from metals that work at high temperature, such as silver or gold. The inventors chose a thick film process using alumina substrates for fabricating one embodiment of the PC board **42**. The alumina substrates are metalized with a thick film gold paste. These substrates performed very well at high temperatures and were very compatible with the die attach process (discussed below). Dupont QG150 brand gold paste was chosen as the metallization. This paste comprises a high-density gold powder with a glass oxide binder. The PC board may be formed of alumina of 10-100 mils thickness. The final substrates comprise 96% alumina substrates measuring 20 mils thick. High density gold paste was used as the conductive layer, and also served as a surface capable of being soldered and wire bonded thereto. Printing capabilities allowed a line resolution of 5 mils.

The PC board **42** is assembled by the following process as outlined hereinabove. The substrates are prepared utilizing a thick film screen printing process. A specialized screen printer is used in conjunction with a patterned stainless steel fine mesh screen. The gold paste is printed onto an alumina (Al_2O_3) substrate. After printing, the paste is dried in an oven at 150°C . to "bake out" the solvents in the paste. Next, the substrates are placed in a furnace and fired at 850°C . During this process, the glass/oxide binders in the paste form a strong bond between the sintered paste and the alumina substrate. Multiple prints require multiple firing steps. In accordance with one embodiment, two printing/firing cycles (top and bottom side metallization) are employed.

Fired substrates are then cut out to the proper dimensions with a dicing saw. The top print has the circuit pattern formed thereon, while the bottom print is a metal plane that has been "meshed" due to printability limitations. The back metal plane will allow metallurgical bonding processes to be performed thereon.

Once the PC board **42** is completed and components attached thereto (described hereinafter), the PC board is then placed into the cavity **34A** and a 12-carat gold wire **44A**, **44B** is laser welded to the PC board and the cavity for forming a retainer to secure the PC board in place. Holding the substrate into the package mechanically is of utmost importance because of the high g-forces exerted on the package and its contents. The retainer may be formed of a material having a coefficient of thermal expansion within 20% of that of the package in order to minimize differential thermal growth there between. It is feasible to add a filler material into the package **34** and to spread it over the PC board and the circuit components to help stabilize their placement during operation. However, any filler used must allow for any expansion or contraction of the components and their connecting wires during temperature cycles. Finally, a lid **34B** is secured to the top of the cavity **34A**. In accordance with one embodiment, Kapton® brand polyimide insulating tape was used to hold the lid **34B** in place until it could be mechanically secured by compression. Another embodiment for securing the lid **34B** is to weld it to the package cavity **34A**.

As will be described in greater detail below, two different circuit layout patterns for the PC boards **42** may be used. A first pattern is designed for a circuit that senses changes of temperature of a selected component of the turbine, wherein the sensor **30** is a thermocouple. The signal indicative of the component temperature is amplified and processed by the circuitry, then transmitted via an FM transmitter and broadcast via an antenna such as the antenna **26**. This type of circuit may be used for sensors other than those measuring temperature, but that also produce a direct-current (D/C) output signal as a response, such as static strain, conductive trace, or chemical sensors. A second pattern is designed for a circuit that senses dynamic strain occurring on a selected component of the turbine, wherein the sensor **30** is a strain gauge. The signal indicative of the dynamic strain occurring on the selected component is amplified and processed by the circuitry, then transmitted via a separate FM transmitter and broadcast via an antenna such as antenna **26**. This type of circuit may be used for sensors other than those measuring dynamic strain, but that also produce an alternating-current (A/C) output signal as a response, such as accelerometers or electromagnetic wave emission detectors. An alternate embodiment uses a single FM transmitter that multiplexes multiple signals for transmission to a single FM receiver configured to decode the received signal into the two separate data signals. The PC board **42**, as shown in FIG. **3**, is partially complete in the illustration and is generally representative of the thermocouple circuit. Both circuits include an open air core wire inductor coil **L1**, which is part of the tank circuit for the Colpitts oscillator of the FM transmitter, which will be explained further herein below. The quality factor Q of the coil **L1** may be at least 5 at the operating temperature and operating frequency of the circuit. Sputtered gold or silver paste material may be used to form the coil; however, such pastes typically have a low Q value. The present inventors have successfully utilized gold or silver wire to form the inductor coil. The metal wire air core conductor may be potted along its length to prevent electrical shorts at high frequencies. Insulating tape may be wrapped on the potted wire where it crosses itself so as to prevent electrical shorts. Alternatively, the metal wire may be formed into a bridge at cross over points thereof in order to prevent electrical shorts. In order to increase the mechanical strength and stability of such a coil, a potting material may be placed around the wire, although any such potting material will necessarily affect the Q factor of the coil. In one embodiment, gold wire potted with a ceramic alumina paste suspension (such as Ceramabond® brand ceramic cement) provided a desired degree of structural stability at gas turbine operating temperatures and G forces and provided a Q factor of greater than 5. Such an alumina-based potting also acts as an electrical insulator for the coil, so no separate electrical insulation is required around the wire itself.

Die/Component Attachment

In order for the electronic package to function at elevated temperatures up to at least 450°C . and to withstand centrifugal loading greater than 1000 g's, special requirements are to be met for attaching components to the PC board **42**. All bonds are performed in a vacuum oven for assurance of proper reflow of the solder. The inventors have appreciated a major problem that may be encountered when the component being soldered has a trivial mass. If the mass of the component is very small, it may be unable to break the surface tension of the liquid alloy as it beads up, and the component

part may be pushed off the solder and slide to another position, or it may tilt at an angle (called "tomb stoning").

To overcome this problem, the present inventors have developed an approach utilizing a transfer plate and component alignment templates that fit in the heated fixture of the vacuum oven. A transfer plate **60** is shown in plan and elevation views in FIG. **4A** and a pair of component alignment plates **61** and **62** are shown in FIG. **4B**, also in plan view. FIG. **4A** illustrates plan and end views of the transfer plate **60** used in assembling the PC board **42** shown in FIG. **3**. The plate is made of graphite and is sized and shaped for receipt of the substrate (PC board) and the alignment plates **60**, **61** for aligning the components to be attached to the PC board during the assembly operation. The alignment plates **60**, **61** must be capable of withstanding high-temperatures, must be inert and resistant to solder, and must be capable of defining highly precise cutouts for the components. Accordingly, alloy 316 stainless steel may be used to fabricate these plates. Due to the small size of the cutouts and the need for high precision, laser cutting may be used for fabrication.

The next concern is the formulation of the solder for attaching the components to the PC board **42**. The material must be compatible with the die metallization (Au thin film) and the substrate metallization (Au thick film).

Brazing, which is a relatively straightforward process involving the melting of a high temperature filler metal in between two wetting surfaces, was found to be less than optimal for the present application due to three primary factors: (1) most brazes have a liquidus temperature over 700° C. and require highly corrosive fluxes; (2) many brazing alloys are not eutectic and have a very large plastic region which may complicate processing; and, (3) most brazes are not compatible with gold surfaces.

The inventors also found Transient Liquid Phase (TLP) bonding to be less than optimal. In this process, a low melting point alloy is liquefied between two compatible surfaces. As the alloy fills in the gaps between the faying surfaces, it acts to "dissolve" or "leach" away compatible metals. This action changes the composition of the alloy, thereby shifting the melting point of the filler, resulting in solidification and an extremely high quality bond. The primary requirement of this process is that the surfaces being bonded to are thick while the molten alloy layer is extremely thin. When this process was applied to plated thin film (20 microns thick) and thick film (25 microns thick) substrates, the inventors found a very large inconsistency in the results with many not passing acceptance requirements.

The inventors have discovered that a solid state diffusion process utilizing pure gold is useful for the present application. In this process, no liquid metal is utilized. Instead, the rapid self diffusion property of gold is used to create a very high quality bond between two pure gold surfaces. While solid state diffusion may be performed with no filler material, it typically requires very high pressures to compress the facing surfaces together to obtain suitable contact area. In lieu of such pressure, the inventors selected a gold filler material to fill in the gaps between the bonding surfaces. Both gold foil and powder were investigated, with powder proving to be the better option, due to its ability to both fill in the gaps and to form a solid, homogeneous layer under heating due to sintering. Sintering is a process utilizing diffusion to join two small particles together into a solid matrix. This is generally performed at elevated temperature to increase the rate of diffusion. While the solid state diffusion process may be performed with a gold powder, it was further discovered that a gold paste was easier to use in this application. A paste may be applied by a number of methods, including dispensing,

stamping, and screen printing. The major difference between a gold paste and a gold powder is that the paste has both an organic vehicle (such as polymers, terpineol, or glycol ethers) which acts as a transfer medium so that the powder may be easily applied, and surfactants that act to separate the powders until bonding is desired.

A number of gold thick film pastes were selected for use. While the paste has other additives (oxide based binders and glass frits) which will provide no adhesion to a pure gold layer, they are compatible with alumina substrates and thick film gold metallization. Additionally, these pastes are readily available, contain small high purity gold powder, and are designed for easy application. While many gold pastes have proved compatible, the best performing option was found to be DuPont QG 150, which is the paste with the highest gold composition available. This is the same paste used to metalize the substrate, and thus is very compatible with the entire system. In this process, the die and components are placed upon the gold metalized substrate with a small amount of the QG 150 gold paste. The assembly is then placed in an oven at 400° C. for 12 hours. During this time, the gold-gold diffusion takes place between neighboring gold particles and between the particles and the bonding surfaces. The resulting bond is very strong and capable of withstanding temperatures well above 500° C. Additionally, the process is straightforward, fast, repeatable, and may be performed on very small components.

Referring now to FIGS. **5A**, **5B** and **5C**, perspective views of the transfer plates used for aligning and assembling the components on the circuit board are shown. First, the substrates or PC boards **42** are placed in the cavities of the transfer plate **60**. Next, the alignment plates **61**, **62** are placed over the substrates. The component attachment gold paste is then placed in the openings of the alignment plates and the components are then placed in the openings of the alignment plates **60**, **61** for the assembly operation. The transfer plate **60** along with the substrates, alignment plates, gold paste and components are sandwiched between heated graphite plates **65**, as shown in FIG. **5C**. The assembly is next placed in an oven at 400° C. for 12 hours. During this time, gold to gold diffusion takes place, and the die and components remain attached with a high shear strength at temperatures greater than 500° C. The process is made repeatable by a pick-and-place machine that properly aligns the die and components.

Wire Bonding

Wire bonds are the standard method used in many electronic applications; however, they are not known by the inventors to be employed in an environment that subjects them to such high sheer forces (i.e., g-loading) while at high temperatures. Referring now to FIGS. **6A** and **6B**, wire bonding techniques typically used in the semiconductor arts are shown. FIG. **6A** illustrates the foot and heel of each end of the bonding wire, and FIG. **6B** illustrates the terms "loop height" and "bond length". FIG. **7** is a perspective view showing g-force analysis of a typical wire bonding, wherein the g forces are applied from four different directions. First, there are two possible forces in opposite directions across the wire bond (i.e. in directions parallel to the wire) that are labeled as the X and -X direction, and then there are two possible forces in opposite directions into the wire bond (i.e. in directions perpendicular to the wire) that are labeled as the Z and -Z direction. FIG. **8** illustrates diagrams of the wire bonding showing deformation of the wire under simulated g-force stress in these various directions. The interconnect technol-

ogy used to connect integrated circuits to a PC board is a critical component to any electronic system.

Under high g-forces, it is normally expected that the wire bonds would deflect to a certain degree from their original position. The present inventors have unexpectedly discovered that it is possible to utilize gold wire bonds in the high temperature and high g environment of the present invention. It was found that loading of the wire bond in the X direction (Load Set 2 in FIG. 8) resulted in the least overall stresses in the wire. Gold wire bonds of both 0.7 and 1.0 mil diameter have been used. It has been shown that both diameters of wire bonds will be structurally stable if they are oriented parallel to the centrifugal loading, the maximum loop height is no greater than 17.4 mil, and the maximum bonding length (from bonding pad to bonding pad) is kept under 35 mil. These results are acceptable for loadings of greater than 1,000 g's, and in fact, were tested to be acceptable to loadings over 10,000 g's. The wire properties, loop height, bonding length and temperature all affect the maximum sustainable G-load of the wire bond.

Electronics

Referring now to FIG. 9A, an exemplary schematic diagram is shown that illustrates the unique circuit biasing for amplifier circuits used herein. The function of the bias circuit is to place the JFET's into the proper area of operation. For a JFET, the places of operation can be various points within the ohmic region, where the JFET behaves as a small resistor, or within the saturation region, where the JFET behaves as a voltage controlled current source. Different biasing points lead to different JFET behavior; even different points within the same region. Many of the JFET's characteristics change when the JFET is operated over the temperature range of 25° C. to 500° C. Of specific interest herein is the fact that the device is going to exhibit less gain at high temperature than at low temperature. Another important change is the characteristics of the JFET performance over temperature, which is the downward (more negative) shift of the JFET threshold voltage over increasing temperature, which is demonstrated in the diagram of FIG. 9B.

Structurally, the amplifier circuit shown in FIG. 9A includes a voltage divider network comprising RB_1 and RB_2 serially coupled between a source of positive voltage V(+) and source of negative voltage V(-). A circuit node 1000 connecting RB_1 to RB_2 is coupled to one side of an input capacitor C_1 and to the gate terminal of a JFET Q1. The other side of C_1 is coupled to the input terminal V(in). The source terminal of the JFET Q1 is coupled to ground potential, and the drain terminal thereof is coupled to one side of a load resistor RD. The other side of the resistor RD is coupled to the source of positive voltage V(+). The drain terminal of Q1 is also coupled to the output terminal V(out) through another capacitor C_2.

FIG. 9B illustrates the changing level of AC output voltage versus bias voltage of the amplifier of FIG. 9A under varying temperatures. That is, the level of voltage on the node 1000 is plotted on the horizontal axis of FIG. 9B, and the resulting output voltage V(out) is plotted on the vertical axis. Curve 1001 represents the output voltage at a temperature of 25° C.; curve 1002 represents the output voltage at 100° C.; curve 1003 represents the output voltage at a temperature of 200° C.; curve 1004 represents the output voltage at a temperature of 300° C.; curve 1005 represents the output voltage at a temperature of 400° C.; and, curve 1006 represents the output voltage at a temperature of 500° C.

In a JFET common source ac amplifier (e.g., FIG. 9A), there is a narrow range of bias voltage that results in the highest ac voltage gain. Accordingly, as may be seen from this figure, there is a decreased gain over temperature that results in a lower maximum ac output voltage. Also, it is shown that the bias point where the maximum peak-to-peak output voltage occurs shifts to the left (more negative dc gate bias voltage with increased temperature). The ideal biasing circuit will track the peak thereby providing optimal performance. Hence, it is desirable to adapt the biasing dc voltage with temperature changes.

The resistors RB_1 and RB_2 set the dc operating point of the gate to source voltage (V_{gs}) of the common source amplifier (FIG. 9A), which is the same voltage as that depicted on the horizontal axis of FIG. 9B. For example, the bias point for the peak ac voltage output at 25° C. is where V_{gs} = -1.7 v. The resistor RD is the JFET drain resistor, which helps determine the voltage gain of the amplifier. Two characteristics that must be accounted for when biasing the circuit over the temperature excursion (of 25° C. to 450° C.) are the bias point set by resistors RB_1 and RB_2, which should track the voltage results in the peak output voltage; and, the gain of the circuit should be increased with increasing temperature. If the above two measures are taken, the output characteristics of the device will remain essentially constant over the temperature range of interest. This can be accomplished by designing the resistor RB_1 to have a positive temperature coefficient (PTC) of resistance, while the resistor RB_2 has a zero temperature coefficient (ZTC) of resistance. A second approach is to give the resistor RD a PTC as well, so as to increase the amplifier gain as the temperature increases (resulting in a gain at high temperature equal to that at low temperature).

Temperature coefficients of resistance can be implemented in several ways. They can potentially be applied using surface mount thermistors or they can be fabricated with different materials affixed to the circuit board. There are many thick film pastes available that possess various temperature coefficient of resistance (TCR). In accordance with one embodiment, the resistors RB_1 and RD are formed of TaN Thick Film, while the resistor RB_2 is formed of Platinum Thick Film.

Referring now to FIG. 10, a block diagram of the strain gauge circuit is shown. A signal indicative of the amount of strain placed on a measured turbine component is produced by a strain gauge 101. This signal is then sensed by a differential amplifier 102 and coupled to an AC amplifier 103 for further amplification. The amplified strain gauge signal is then applied to the input of a voltage controlled oscillator 104, which produces an oscillatory signal the frequency of which is representative of the strain placed on the measured turbine component. This oscillatory signal is then buffered by a buffer 105 and passed on to the antenna 26 for transmission to a conventional tuner (not shown) tuned to the carrier frequency.

Referring now to FIG. 11, a block diagram of the thermocouple circuit is shown. A signal indicative of the temperature of a measured turbine component is detected by a thermocouple 110, which signal is passed on to a differential amplifier 111. The output of the differential amplifier 111 is passed on to a dc amplifier 112. The output of the amplifier 112 and the output of a square wave oscillator 113 (or square wave generator) are coupled to inputs of a "chopper" 114. The output of the chopper 114 is coupled to the input of a voltage controlled oscillator 115, which produces an oscillatory signal the frequency and amplitude of which is representative of the temperature sensed on the measured turbine component. This oscillatory signal is then buffered by a buffer 116 and passed on to the antenna 26 for transmission to a conventional

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tuner (not shown) tuned to the carrier frequency. Where both types of circuits are used on the same turbine, the carrier frequencies would be different in order to avoid confusion between the two signals.

Referring now to FIG. 12, a schematic diagram of the circuits 101, 102, and 103 for amplifying a strain gauge output signal is shown. Modification of the traditional wireless telemetry circuit design was required in order to accomplish the required tasks electrically with a more limited selection of available electrical devices usable at temperatures in excess of 450° C. A strain Gauge signal conditioning (excitation and amplification) circuit was designed using only one type of transistor, a JFET with high temperature metallization. The connection of the metal bonding pads (i.e., gold) cannot be made directly to the semiconductor material, but must utilize an adhesion layer, such as Tungsten, and perhaps adding a diffusion barrier as well. These metals comprise the “metal stack” of the die, i.e., high temperature metallization.

Structurally, there is a voltage divider network comprising resistor R7 and a Strain Gauge coupled between a source of positive voltage Vdc(+) and ground potential. Circuit node 1100 is the connection point between resistor R7 and the Strain Gauge, and is also coupled through a capacitor C4 to the gate terminal of a JFET transistor J1. The transistor J1 is biased by a pair of resistors RB_1 and RB_2 which are joined at the gate terminal of this transistor, in the same manner as described above with reference to FIG. 9A. Transistor J1 is half of a differential amplifier that includes transistor J2. The drain terminal of the transistor J1 is coupled to the positive voltage Vdc(+) through a resistor R1 and the drain terminal of the transistor J2 is coupled to the same Vdc(+) through a resistor R2. The source terminals of the transistors J1 and J2 are coupled together and to the drain terminal of another transistor J3, which includes a gate terminal coupled to ground potential and the source terminal thereof coupled also to ground potential through another resistor R3. The gate terminal of the transistor J2 is also coupled to ground potential. Therefore, any change on the gate terminal of the transistor J1 will be amplified at the drain terminal thereof and coupled through a capacitor C1 to the gate terminal of yet another transistor J4, which is the first of three more stages of amplification (ac amplifier 103) including transistors J5 and J6, with the output of the amplifier provided at a terminal Vout.

A change in the strain placed on the component being measured, which component includes the Strain Gauge, changes the resistance of the Strain Gauge resistor, thereby changing the voltage at the gate terminal of the transistor J1. This changes the output of the transistor J1 across a resistor R1, which is coupled to succeeding stages of amplification by the transistors J4, J5 and J6. All of the resistors shown in FIG. 13, with the exception of the resistor RB_2 (which has a ZTC), have a very low (close to zero, slightly positive) temperature coefficient of resistance. Also, all of the JFET transistors are made with high temperature metallization, as described hereinabove.

Referring now to FIG. 13, a schematic diagram of the circuits 110, 111 and 112 for amplifying a thermocouple output and embedding the local temperature of the thermocouple circuitry into the amplified output signal is shown. In this manner, the thermal gradient across the thermocouple, rather than just the thermocouple output, can be transmitted, thus giving an accurate temperature measurement. FIG. 16 illustrates the thermocouple 110 coupled to the circuitry shown in the block diagram of FIG. 11 (i.e., the thermocouple circuitry 201). The thermocouple 110 output is shown as representing $\Delta T^\circ C$. As will be shown and described further

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hereinafter it is the sum of $\Delta T^\circ C$. and the local temperature of the thermocouple circuitry 201 that represents the true measured temperature of the turbine.

Referring again to FIG. 13, the negative leg of the thermocouple is grounded, and the positive leg is connected to the gate terminal of a transistor J7, which along with transistor J8, forms the differential amplifier 111. This differential amplifier is biased by the voltage divider comprising RB_1 and RB_2 coupled together at the gate terminal of transistor J7 plus a current source formed with a transistor J9. As described hereinabove, the resistors RB_1 has a PTC and the resistor RB_2 has a ZTC in order to compensate for the high temperature environment (see FIG. 9A and accompanying description).

Since the thermocouple signal is dc, or very low frequency ac, successive amplification stages cannot be capacitively coupled. Instead, a transistor J10 is used in the source follower configuration to shift the output of the differential amplifier down to the level at which the common source transistor J11 must be biased. The transistor J11 serves to further amplify the signal. Transistors J12 and J14 form another level shifting and amplification stage (dc amplifier 112). At this point, the output of the thermocouple has been amplified to an appropriate level. Now the local temperature of the thermocouple circuitry must be embedded into the amplified signal.

Transistors J14 and J15 form a differential pair amplifier, biased by a current source formed by a transistor J16. Capacitors C6 and C7, along with resistors R18, R19 and R20 form a -90° to $+90^\circ$ phase shift network. This phase shift network is connected at one end of the amplifier input at the transistor J15, and the other end is coupled to the output of the amplifier (the drain terminal of the transistor J14), which comprises an RC feedback network. This configuration forms a relaxation type RC oscillator (square wave oscillator 113). Capacitors C6 and C7 are NP0 type capacitors, and their capacitance does not change appreciably over the temperature excursion of 25° C. to 450° C. An NP0 capacitor dielectric has a negative-positive-zero temperature coefficient of capacitance, wherein the positive and negative temperature coefficients cancel one another out. Capacitor C8 is coupled in series between the RC feedback network and the output of the differential amplifier at the drain terminal of transistor J14. This capacitor is made with an X7R dielectric, and thus its capacitance changes predictably with temperature changes. X7R is a capacitor dielectric that has a higher dielectric constant than does the NP0 dielectric, but has a large capacitance dependence on temperature (which is predictable). The output of this oscillator is a square wave with a frequency determined by the temperature dependent capacitor C8; thus, the local temperature of the thermocouple circuitry may be encoded into the square wave signal. (See the oscillator 113 output waveform 210 shown in FIG. 17 at room temperature; and the same oscillator output waveform 212 at an elevated temperature, shown in FIG. 18). A transistor J27 serves as a chopper transistor (i.e., chopper 114). The amplified thermocouple output from the transistor J13 (waveform 214 in FIG. 19) is coupled to the drain terminal of the transistor J27, while the square wave oscillator output is coupled to the gate terminal of the same transistor J27. The source of the transistor J27 provides a square wave output, whose amplitude is proportional to the temperature of the thermocouple 110 and whose frequency is proportional to the temperature of the thermocouple circuitry (see waveform 216 shown in FIG. 20). Thus, the signal contains the thermocouple output plus the temperature of the thermocouple circuitry, which signal is applied to the voltage controlled oscillator 115.

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By way of example of operation of the thermocouple **110** and its circuitry **113**, assume that the temperature of the circuitry **113** is at 25° C. and the corresponding output of the oscillator **113** is at a frequency of 1.62 kHz (waveform **210**, FIG. **17**). Also, assume for the particular thermocouple **110** being used that a 12 mv output voltage (waveform **214**, FIG. **19**) corresponds to a ΔT of 320° C. Now, assume that the temperature of the circuitry **113** is 325° C. and the output of the oscillator **113** is 5.44 kHz (waveform **212**, FIG. **18**). By combining the waveforms **212** and **214** with the transistor **J27**, the resultant output of the transistor **J27** (i.e., output of the circuit) is illustrated by the waveform **216**. Thus, the resulting temperature measured is 645° C. at the hot end of the thermocouple. The frequency of the waveform **216** represents the temperature of the local circuitry **113** and the amplitude represents ΔT . Accordingly, one skilled in the art can construct circuitry associated with the FM receiver (not shown) to perform signal decoding and addition operations.

Referring now to FIG. **14**, a schematic diagram of the power conditioning circuitry is shown. A power conditioning circuit capable of rectifying an RF input voltage, filtering and rectified voltage, and regulating that voltage had to be designed using only one type of transistor and available diodes. The circuit rectifies RF induction power provided by the rotating turbine and delivers a positive and negative regulated dc voltage. Details of the RF induction power generator are amplified in the above-cited co-pending patent application entitled INSTRUMENTED COMPONENT FOR WIRELESS TELEMETRY. Structurally, diodes **D5** through **D8**, as well as diodes **D9** through **D11**, serve as a bridge rectifier. An ac voltage on terminals **Vac1** and **Vac2** or **Vac3** or **Vac4** is full-wave rectified into a dc voltage with a large ripple. Capacitors **C9** through **C12** serve as filter capacitors in order to reduce the ripple to a sufficiently low level. Transistors **J17** and **J21** serve as constant current sources, delivering a constant current into resistors **R26** and **R30**, respectively. This constant current going through a constant resistance produces a constant voltage, which is coupled to transistors **J19** and **J23**. This constant voltage biases transistors **J19** and **J23** such that, after a threshold determined by the **R25/R26** resistor pair or **R29/R30** resistor pair, any increasing voltage at the inputs to the transistors does not contribute to an increasing voltage at the transistor outputs. The increasing voltage input is dissipated as heat in the transistors **J19** and **J23**. Thus, the transistors **J17** and **J19**, as well as transistors **J21** and **J23** comprise low-dropout (LDO) voltage regulators. These regulators are repeated with the transistors **J18** and **J20**, as well as the transistors **J22** and **J24** to improve the net voltage regulation. The voltages are then supplied as either positive or negative regulated voltages **Vdc(+)** or **Vdc(-)**, respectively.

In accordance with one embodiment the resistors **R26**, **R28**, **R30** and **R32** have a PTC, whereas the resistors **R25**, **R27**, **R29** and **R31** have a ZTC. As discussed hereinabove, this arrangement of resistors compensates for changes in bias voltages at elevated temperatures. In this way the circuit self compensates for temperature variations and keeps the voltage drop across the transistors **J19**, **J20**, **J23** and **J24** constant. As described hereinabove, PTC resistors may be made of platinum and ZTC resistors may be made of tantalum nitride. It is pointed out that the circuit would also function the same where the resistors **R26**, **R28**, **R30** and **R32** were made with ZTC and the resistors **R25**, **R27**, **R29** and **R31** were made with a negative temperature coefficient (NTC) by the use of a silicon resistor, such as silicon carbide.

Referring now to FIG. **15**, a schematic diagram of the FM transmitter (i.e., VCO **104** and Buffer **105**) is shown. In order

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to create a frequency modulated (FM) signal, a variable impedance device is commonly used to encode (i.e., modulate) information onto an RF carrier wave. A common way to do this task in low-temperature circuitry is to use a device whose capacitance has a dependence on applied voltage. Almost all pn junction diodes exhibit this characteristic when reverse biased; that is, a varying voltage applied to a reversed biased diode affects change in the capacitance across the diode. For low-temperature radio applications, a special diode, called a varactor, is used for this purpose. The varactor is a pn junction diode, with a "hyper-abrupt" junction (i.e., a junction that is heavily doped to promote a large tuning angle) and is fabricated from silicon or gallium arsenide.

The circuit shown in FIG. **15** includes a Colpitts oscillator comprising an inductor **L1** and serially coupled capacitors **C13** and **C14**, both of which are coupled in parallel with the inductor **L1**. A transistor **J25** serves as the active device in the Colpitts oscillator. The carrier frequency of the oscillator is determined by the value of the inductor **L1** and the capacitors **C13** and **C14**. A diode **D13**, which is coupled in parallel with the capacitor **C14**, serves as a voltage variable capacitor, or varactor, which modulates (i.e., encodes) an ac voltage onto the carrier wave. The carrier wave is then capacitively coupled into a transistor **J26**, which serves as both a buffer transistor as well as a power amplifier. The cathode of the diode **D13** is coupled to a circuit node **1400** and the anode thereof is coupled to the ground potential. The circuit junction between the capacitors **C13** and **C14** is coupled to the node **1400**, which also comprises the input terminal **V(in)** to the circuit. The output of the circuit is then capacitively coupled into the transmit antenna (not shown).

In high-temperature applications, typical varactors cannot be used and are not useful in the FM transmitter of interest herein because the capacitance of this varactor is non-linear over a range of applied bias voltages at elevated temperatures. Hence, correct information could not be recovered from the transmitted signal (identical frequency deviations would not correspond to distinct tuning voltages). It was discovered that the problem was intrinsic to SiC itself, and thus no SiC device would achieve the desired result. GaN devices, which can function at high temperatures (i.e., have a linear capacitance over the same range of applied bias voltages at the same elevated temperatures), were explored for use as the varactor diode **D13**. Gallium Nitride (i.e., GaN) is also a wide band gap semiconductor, with a wide band gap energy of 3.4 eV@300 K (whereas SiC is 2.86 eV), meaning that it can function at high temperature (in excess of 600° C.). The only commercially available GaN diode currently available is in the form of a blue or ultraviolet LED, which produced satisfactory results across the temperature excursion of interest herein.

While various embodiments of the present invention have been shown and described herein, it will be obvious that such embodiments are provided by way of example only. Numerous variations, changes and substitutions may be made without departing from the invention herein. Accordingly, it is intended that the invention be limited only by the spirit and scope of the appended claims.

The invention claimed is:

1. In a telemetry system for use in an internal combustion engine, a circuit structure affixed to a moving part of said engine and being disposed for processing information sensed about the temperature of said moving part, said circuit structure being adapted for the high temperature environment of said engine and comprising:

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a thermocouple disposed on said moving part for sensing a temperature thereof and providing a signal representative of the temperature sensed;

an amplifier having an input coupled to an output of said thermocouple and being disposed for amplifying the signal representative of the temperature sensed by said thermocouple;

a square wave oscillator disposed for generating a square wave signal having a frequency indicative of a local temperature of said circuit structure;

a chopper disposed for converting an output signal of said amplifier into an alternating current signal, said chopper having a first gating input coupled to an output of said square wave oscillator and a second input coupled to an output of said amplifier, said chopper having an output providing a signal having a frequency representative of the local temperature of said circuit and an amplitude representative of the temperature sensed by said thermocouple.

2. The system as in claim 1 wherein said square wave oscillator includes a feedback coupling capacitor having a capacitance variable with temperature, whereby an increase in the local temperature of said circuit structure causes a decrease in capacitance of said coupling capacitor thereby causing a predictable increase in the frequency of said output signal of the square wave oscillator.

3. The system as in claim 1 wherein said square wave oscillator includes a differential amplifier having an RC feedback network coupled between the input and the output of said amplifier and having a capacitor coupled between said RC feedback network and said output of said amplifier, wherein said capacitor has a temperature sensitive dielectric so that a capacitance thereof changes proportionally in response to changes in temperature, thereby changing the frequency of said square wave signal in response to changes in temperature.

4. The system as in claim 3 wherein the dielectric of said capacitor is classified as X7R.

5. The system as in claim 1 further comprising structure for transmitting said sensed information to a receiver external to said engine comprising a voltage controlled oscillator having an input disposed for receiving said alternating current signal from said chopper and for producing a radio frequency signal representative of the temperature sensed by said thermocouple, said radio frequency signal being coupled to an antenna for transmission to a receiver remote from said engine.

6. The system as in claim 5 further comprising a buffer coupled between said voltage controlled oscillator and said antenna for buffering said radio frequency signal.

7. The system as in claim 5 wherein said voltage controlled oscillator comprises a Colpitts oscillator for setting a reference carrier frequency.

8. The system as in claim 7 wherein said Colpitts oscillator comprises an inductance coil in parallel with a pair of serially coupled capacitors at a circuit node.

9. The system as in claim 8 wherein said inductance coil comprises a coil of wire formed directly on a printed circuit board supporting said circuit.

10. The system as in claim 7 wherein said Colpitts oscillator comprises a gallium nitride (GaN) LED diode coupled in a reverse bias configuration as a varactor and in parallel with one of said capacitors between said circuit node and ground potential.

11. The system as in claim 10 wherein said LED diode comprises indium gallium nitride (InGaN).

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12. The system as in claim 1, further comprising an ac power conditioning circuit for providing dc power to the circuit structure, said ac power conditioning circuit including an array of rectifying diodes, filtering capacitors, and temperature compensating voltage regulators, each comprising:

a first transistor coupled in parallel with said filtering capacitors and having a source terminal coupled to ground potential through a pair of resistors and having a gate terminal coupled to the junction between said pair of resistors, a first of said pair of resistors having a zero coefficient of resistance coupled between said source terminal and the junction and a second of said pair of resistors having a positive coefficient of resistance coupled between the junction and ground potential, whereby said first transistor and pair of resistors act as a constant current source;

a second transistor coupled in series with the positive output of said ac power conditioning circuit and having a gate terminal coupled to the junction between said pair of resistors, whereby the bias voltage on said gate terminal of said second transistor shifts as a function of temperature changes, thereby making the voltage drop across said second transistor constant over a range of temperature changes.

13. The system as in claim 12 wherein in said ac power conditioning circuit said first of said pair of resistors comprises tantalum nitride.

14. The system as in claim 12 wherein in said ac power conditioning circuit said second of said pair of resistors comprises platinum.

15. The system as in claim 12 wherein in said ac power conditioning circuit said first of said pair of resistors has a negative coefficient of resistance and comprises silicon carbide.

16. The system as in claim 12 wherein in said ac power conditioning circuit said second of said pair of resistors has a zero coefficient of resistance and comprises tantalum nitride.

17. In a telemetry system for use in an internal combustion engine, a circuit structure affixed to a moving part of said engine and being disposed for processing information sensed about a temperature of said moving part and for transmitting said sensed information to a receiver external to said engine, said circuit structure being adapted for the high temperature environment of said engine and comprising:

a thermocouple disposed on said moving part for sensing the temperature thereof and providing a signal representative of the temperature sensed;

an amplifier having an input coupled to an output of said thermocouple and being disposed for amplifying the signal representative of the temperature sensed by said thermocouple;

a square wave oscillator disposed for generating a square wave signal having a frequency indicative of a local temperature of said circuit structure and including a feedback coupling capacitor having a capacitance variable with temperature, whereby an increase in the temperature of said circuit structure causes a decrease in capacitance of said coupling capacitor thereby causing a predictable increase in the frequency of said square wave signal;

a chopper disposed for converting an output signal of said amplifier into an alternating current signal, said chopper having a first gating input coupled to an output of said square wave oscillator and a second input coupled to the output of said amplifier, said chopper having an output providing a signal having a frequency representative of

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the local temperature of said circuit structure and an amplitude representative of the temperature sensed by said thermocouple; and,
 a voltage controlled oscillator having an input disposed for receiving said alternating current signal from said chopper and for producing a radio frequency signal representative of the temperature sensed by the thermocouple, said radio frequency signal being coupled to an antenna for transmission to a receiver remote from said engine.

18. The system as in claim **17** wherein said square wave oscillator comprises a differential amplifier having an RC feedback network coupled between an input and an output of said amplifier and having a capacitor coupled between said RC feedback network and said output of said amplifier, wherein said capacitor has a temperature sensitive dielectric so that the capacitance thereof changes proportionally in response to changes in temperature, thereby changing the frequency of said square wave signal in response to changes in temperature.

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19. The system as in claim **18** wherein the dielectric of said capacitor is classified as X7R.

20. The system as in claim **17** wherein said voltage controlled oscillator comprises a Colpitts oscillator for setting a reference carrier frequency, said oscillator comprises an inductance coil in parallel with a pair of serially coupled capacitors at a circuit node and comprising a coil of wire formed directly on a printed circuit board supporting said circuit.

21. The system as in claim **20** wherein said Colpitts oscillator comprises a gallium nitride (GaN) LED diode coupled in a reverse bias configuration as a varactor and in parallel with one of said capacitors between said circuit node and ground potential.

* * * * *

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 8,092,080 B2
APPLICATION NO. : 12/192366
DATED : January 10, 2012
INVENTOR(S) : David J. Mitchell et al.

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

ON THE TITLE PAGE

Assignees should read: Siemens Energy, Inc., Orlando, FL (US)
Arkansas Power Electronics International, Inc., Fayetteville, AR (US)

Signed and Sealed this
Tenth Day of May, 2016



Michelle K. Lee
Director of the United States Patent and Trademark Office